



## TPA6211A1 3.1-W Mono Fully Differential Audio Power Amplifier

### 1 Features

- Designed for Wireless or Cellular Handsets and PDAs
- 3.1 W Into 3  $\Omega$  From a 5-V Supply at THD = 10% (Typ)
- Low Supply Current: 4 mA Typ at 5 V
- Shutdown Current: 0.01  $\mu$ A Typ
- Fast Startup With Minimal Pop
- Only Three External Components
  - Improved PSRR ( $-80$  dB) and Wide Supply Voltage (2.5 V to 5.5 V) for Direct Battery Operation
  - Fully Differential Design Reduces RF Rectification
  - $-63$  dB CMRR Eliminates Two Input Coupling Capacitors

### 2 Applications

- Ideal for Wireless Handsets, PDAs, and Notebook Computers

### 3 Description

The TPA6211A1 is a 3.1-W mono fully-differential amplifier designed to drive a speaker with at least 3- $\Omega$  impedance while consuming only 20 mm<sup>2</sup> total printed-circuit board (PCB) area in most applications. The device operates from 2.5 V to 5.5 V, drawing only 4 mA of quiescent supply current. The TPA6211A1 is available in the space-saving 3-mm  $\times$  3-mm SON (DRB) and the 8-pin MSOP-PowerPAD™ (DGN) packages.

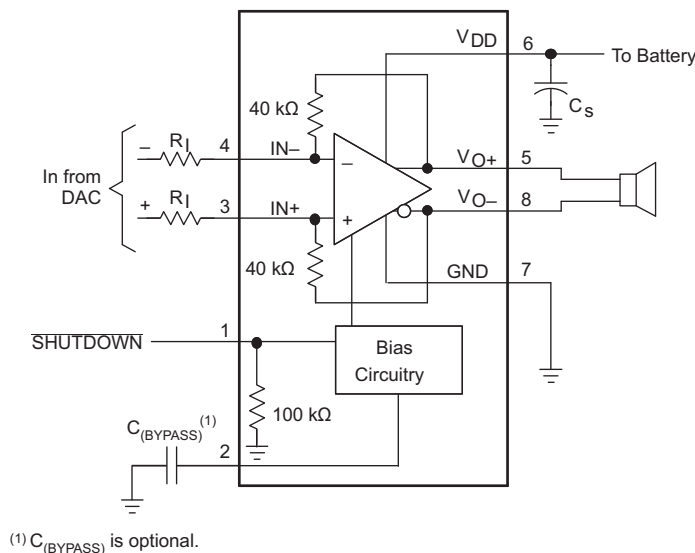
Features like  $-80$  dB supply voltage rejection from 20 Hz to 2 kHz, improved RF rectification immunity, small PCB area, and a fast startup with minimal pop makes the TPA6211A1 ideal for PDA and smart phone applications.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TPA6211A1	MSOP-PowerPAD (8)	3.00 mm $\times$ 3.00 mm
	SON (8)	3.00 mm $\times$ 3.00 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

#### Application Circuit



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## 4 Revision History

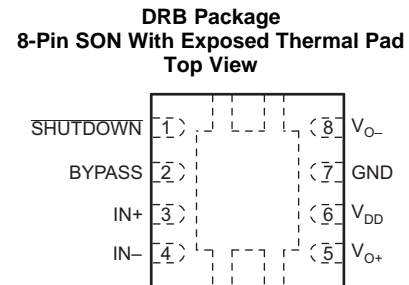
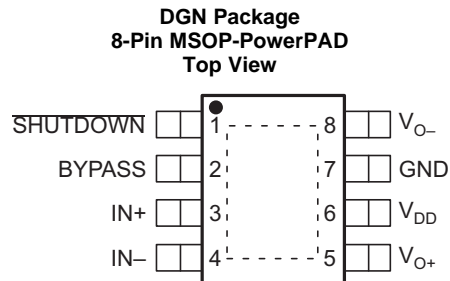
NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision D (June 2011) to Revision E	Page
<ul style="list-style-type: none"> <li>Added ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section. ....</li> </ul>	<b>1</b>
Changes from Revision C (June 2008) to Revision D	Page
<ul style="list-style-type: none"> <li>Deleted the Lead temperature 1,6 mm (1/16 Inch) from case for 10 seconds row from the Abs Max Table .....</li> </ul>	<b>4</b>
Changes from Revision B (August 2004) to Revision C	Page
<ul style="list-style-type: none"> <li>Changed Storage temperature From: –65°C to 85°C To: –65°C to 150°C.....</li> </ul>	<b>4</b>

## 5 Device Comparison Table

DEVICE NUMBER	SPEAKER CHANNELS	SPEAKER AMP TYPE	OUTPUT POWER (W)	PSRR (dB)
TPA6211A1	Mono	Class-AB	3.1	85
TPA6203A1	Mono	Class-AB	1.25	90
TPA6204A1	Mono	Class-AB	1.7	85
TPA6205a1	Mono	Class-AB	1.25	90

## 6 Pin Configuration and Functions



### Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
BYPASS	2	–	Mid-supply voltage, adding a bypass capacitor improves PSRR
GND	7	I	High-current ground
IN+	3	I	Positive differential input
IN-	4	I	Negative differential input
SHUTDOWN	1	I	Shutdown terminal (active low logic)
V <sub>DD</sub>	6	I	Power supply
V <sub>O+</sub>	5	O	Positive BTL output
V <sub>O-</sub>	8	O	Negative BTL output
Thermal Pad	–	–	Connect to ground. Thermal pad must be soldered down in all applications to properly secure device on the PCB.

## 7 Specifications

### 7.1 Absolute Maximum Ratings

over operating free-air temperature range unless otherwise noted<sup>(1)</sup>

	MIN	MAX	UNIT
V <sub>D</sub> Supply voltage	−0.3	6	V
V <sub>I</sub> Input voltage	−0.3	V <sub>DD</sub> + 0.3	V
Continuous total power dissipation	See <a href="#">Dissipation Ratings</a>		
T <sub>A</sub> Operating free-air temperature	−40	85	°C
T <sub>J</sub> Junction temperature	−40	150	°C
T <sub>stg</sub> Storage temperature	−65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### 7.2 ESD Ratings

		VALUE	UNIT
V <sub>(ESD)</sub> Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±4000	V
	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±1000	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 7.3 Recommended Operation Conditions

	MIN	NOM	MAX	UNIT
V <sub>DD</sub> Supply voltage	2.5		5.5	V
V <sub>IH</sub> High-level input voltage	SHUTDOWN			V
V <sub>IL</sub> Low-level input voltage	SHUTDOWN			V
T <sub>A</sub> Operating free-air temperature	−40		85	°C

### 7.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		TPA6211A1		UNIT
		DGN (MSOP-PowerPAD™)	DRB (SON)	
		8 PINS	8 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	62.8	49.2	°C/W
R <sub>θJC(top)</sub>	Junction-to-case (top) thermal resistance	61.9	24.8	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	42.1	58.8	°C/W
ψ <sub>JT</sub>	Junction-to-top characterization parameter	3.3	1.7	°C/W
ψ <sub>JB</sub>	Junction-to-board characterization parameter	41.9	25	°C/W
R <sub>θJC(bot)</sub>	Junction-to-case (bottom) thermal resistance	11	8.4	°C/W

- (1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).

### 7.5 Electrical Characteristics

T<sub>A</sub> = 25°C

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>OS</sub> Output offset voltage (measured differentially)	V <sub>I</sub> = 0 V differential, Gain = 1 V/V, V <sub>DD</sub> = 5.5 V	−9	0.3	9	mV
PSRR Power supply rejection ratio	V <sub>DD</sub> = 2.5 V to 5.5 V		−85	−60	dB
V <sub>IC</sub> Common mode input range	V <sub>DD</sub> = 2.5 V to 5.5 V	0.5		V <sub>DD</sub> −0.8	V

## Electrical Characteristics (continued)

 $T_A = 25^\circ\text{C}$ 

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
CMRR	Common mode rejection ratio	$V_{DD} = 5.5\text{ V}$ , $V_{IC} = 0.5\text{ V to } 4.7\text{ V}$		-63	-40	dB
		$V_{DD} = 2.5\text{ V}$ , $V_{IC} = 0.5\text{ V to } 1.7\text{ V}$		-63	-40	
Low-output swing	$R_L = 4\ \Omega$ , $V_{IN+} = V_{DD}$ , $V_{IN-} = 0\text{ V}$	Gain = 1 V/V, $V_{IN-} = 0\text{ V or } V_{DD}$	$V_{DD} = 5.5\text{ V}$	0.45		V
			$V_{DD} = 3.6\text{ V}$	0.37		
			$V_{DD} = 2.5\text{ V}$	0.26	0.4	
High-output swing	$R_L = 4\ \Omega$ , $V_{IN+} = V_{DD}$ , $V_{IN-} = V_{DD}$	Gain = 1 V/V, $V_{IN-} = 0\text{ V or } V_{DD}$	$V_{DD} = 5.5\text{ V}$	4.95		V
			$V_{DD} = 3.6\text{ V}$	3.18		
			$V_{DD} = 2.5\text{ V}$	2	2.13	
$ I_{IH} $	High-level input current, shutdown	$V_{DD} = 5.5\text{ V}$ , $V_I = 5.8\text{ V}$		58	100	$\mu\text{A}$
$ I_{IL} $	Low-level input current, shutdown	$V_{DD} = 5.5\text{ V}$ , $V_I = -0.3\text{ V}$		3	100	$\mu\text{A}$
$I_Q$	Quiescent current	$V_{DD} = 2.5\text{ V to } 5.5\text{ V}$ , no load		4	5	mA
$I_{(SD)}$	Supply current	$V(\text{SHUTDOWN}) \leq 0.5\text{ V}$ , $V_{DD} = 2.5\text{ V to } 5.5\text{ V}$ , $R_L = 4\ \Omega$		0.01	1	$\mu\text{A}$
Gain		$R_L = 4\ \Omega$	$\frac{38\text{ k}\Omega}{R_I}$	$\frac{40\text{ k}\Omega}{R_I}$	$\frac{42\text{ k}\Omega}{R_I}$	V/V
Resistance from shutdown to GND				100		k $\Omega$

## 7.6 Operating Characteristics

 $T_A = 25^\circ\text{C}$ , Gain = 1 V/V

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$P_O$	Output power	THD + N= 1%, $f = 1\text{ kHz}$ , $R_L = 3\ \Omega$	$V_{DD} = 5\text{ V}$	2.45		W
			$V_{DD} = 3.6\text{ V}$	1.22		
			$V_{DD} = 2.5\text{ V}$	0.49		
		THD + N= 1%, $f = 1\text{ kHz}$ , $R_L = 4\ \Omega$	$V_{DD} = 5\text{ V}$	2.22		
			$V_{DD} = 3.6\text{ V}$	1.1		
			$V_{DD} = 2.5\text{ V}$	0.47		
		THD + N= 1%, $f = 1\text{ kHz}$ , $R_L = 8\ \Omega$	$V_{DD} = 5\text{ V}$	1.36		
			$V_{DD} = 3.6\text{ V}$	0.72		
			$V_{DD} = 2.5\text{ V}$	0.33		
THD+N	Total harmonic distortion plus noise	$f = 1\text{ kHz}$ , $R_L = 3\ \Omega$	$P_O = 2\text{ W}$ , $V_{DD} = 5\text{ V}$	0.045%		
			$P_O = 1\text{ W}$ , $V_{DD} = 3.6\text{ V}$	0.05%		
			$P_O = 300\text{ mW}$ , $V_{DD} = 2.5\text{ V}$	0.06%		
		$f = 1\text{ kHz}$ , $R_L = 4\ \Omega$	$P_O = 1.8\text{ W}$ , $V_{DD} = 5\text{ V}$	0.03%		
			$P_O = 0.7\text{ W}$ , $V_{DD} = 3.6\text{ V}$	0.03%		
			$P_O = 300\text{ mW}$ , $V_{DD} = 2.5\text{ V}$	0.04%		
		$f = 1\text{ kHz}$ , $R_L = 8\ \Omega$	$P_O = 1\text{ W}$ , $V_{DD} = 5\text{ V}$	0.02%		
			$P_O = 0.5\text{ W}$ , $V_{DD} = 3.6\text{ V}$	0.02%		
			$P_O = 200\text{ mW}$ , $V_{DD} = 2.5\text{ V}$	0.03%		
$k_{SVR}$	Supply ripple rejection ratio	$V_{DD} = 3.6\text{ V}$ , Inputs ac-grounded with $C_i = 2\ \mu\text{F}$ , $V_{(RIPPLE)} = 200\text{ mV}_{pp}$	$f = 217\text{ Hz}$	-80		dB
			$f = 20\text{ Hz to } 20\text{ kHz}$	-70		
SNR	Signal-to-noise ratio	$V_{DD} = 5\text{ V}$ , $P_O = 2\text{ W}$ , $R_L = 4\ \Omega$		105		dB
$V_n$	Output voltage noise	$V_{DD} = 3.6\text{ V}$ , $f = 20\text{ Hz to } 20\text{ kHz}$ , Inputs ac-grounded with $C_i = 2\ \mu\text{F}$	No weighting	15		$\mu\text{V}_{RMS}$
			A weighting	12		
CMRR	Common mode rejection ratio	$V_{DD} = 3.6\text{ V}$ , $V_{IC} = 1\text{ V}_{pp}$	$f = 217\text{ Hz}$	-65		dB
$Z_I$	Input impedance		38	40	44	k $\Omega$

## Operating Characteristics (continued)

 $T_A = 25^\circ\text{C}$ , Gain = 1 V/V

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Start-up time from shutdown	$V_{DD} = 3.6\text{ V}$ , No $C_{BYPASS}$		4		$\mu\text{s}$
	$V_{DD} = 3.6\text{ V}$ , $C_{BYPASS} = 0.1\text{ }\mu\text{F}$		27		ms

## 7.7 Dissipation Ratings

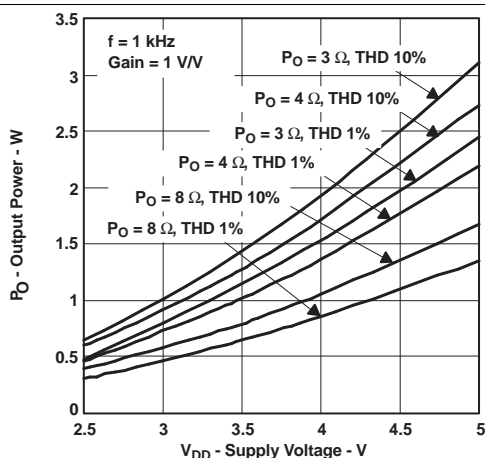
PACKAGE	$T_A \leq 25^\circ\text{C}$ POWER RATING	DERATING FACTOR <sup>(1)</sup>	$T_A = 70^\circ\text{C}$ POWER RATING	$T_A = 85^\circ\text{C}$ POWER RATING
DGN	2.13 W	17.1 mW/ $^\circ\text{C}$	1.36 W	1.11 W
DRB	2.7 W	21.8 mW/ $^\circ\text{C}$	1.7 W	1.4 W

(1) Derating factor based on high-k board layout.

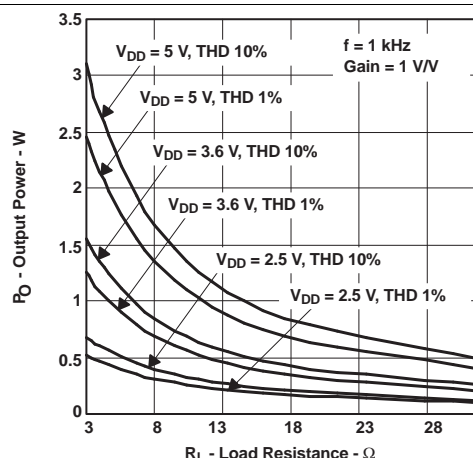
## 7.8 Typical Characteristics

**Table 1. Table of Graphs**

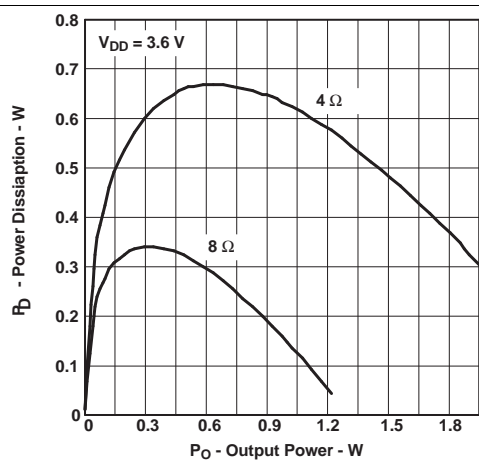
			FIGURE
$P_O$ Output power	vs Supply voltage		<a href="#">Figure 1</a>
	vs Load resistance		<a href="#">Figure 2</a>
$P_D$ Power dissipation	vs Output power		<a href="#">Figure 3</a> , <a href="#">Figure 4</a>
THD+N Total harmonic distortion + noise	vs Output power		<a href="#">Figure 5</a> , <a href="#">Figure 6</a> , <a href="#">Figure 7</a>
	vs Frequency		<a href="#">Figure 8</a> , <a href="#">Figure 9</a> , <a href="#">Figure 10</a> , <a href="#">Figure 11</a> , , <a href="#">Figure 12</a>
	vs Common-mode input voltage		<a href="#">Figure 13</a>
$K_{SVR}$ Supply voltage rejection ratio	vs Frequency		<a href="#">Figure 14</a> , <a href="#">Figure 15</a> , <a href="#">Figure 16</a> , <a href="#">Figure 17</a>
$K_{SVR}$ Supply voltage rejection ratio	vs Common-mode input voltage		<a href="#">Figure 18</a>
GSM Power supply rejection	vs Time		<a href="#">Figure 19</a>
GSM Power supply rejection	vs Frequency		<a href="#">Figure 20</a>
CMRR Common-mode rejection ratio	vs Frequency		<a href="#">Figure 21</a>
	vs Common-mode input voltage		<a href="#">Figure 22</a>
Closed loop gain/phase	vs Frequency		<a href="#">Figure 23</a>
Open loop gain/phase	vs Frequency		<a href="#">Figure 24</a>
$I_{DD}$ Supply current	vs Supply voltage		<a href="#">Figure 25</a>
	vs Shutdown voltage		<a href="#">Figure 26</a>
Start-up time	vs Bypass capacitor		<a href="#">Figure 27</a>



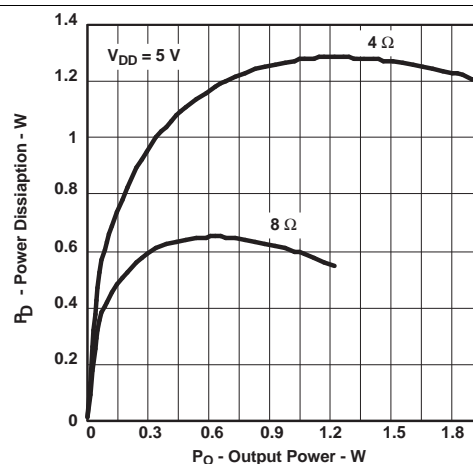
**Figure 1. Output Power vs Supply Voltage**



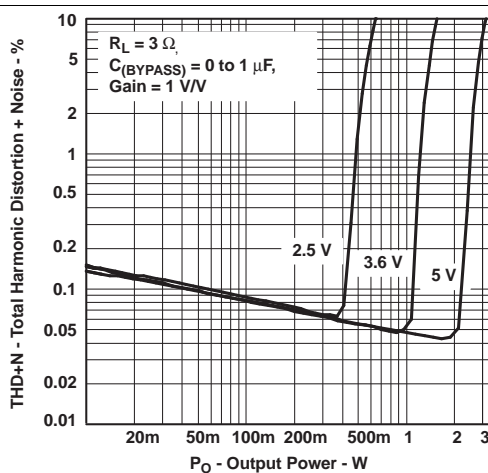
**Figure 2. Output Power vs Load Resistance**



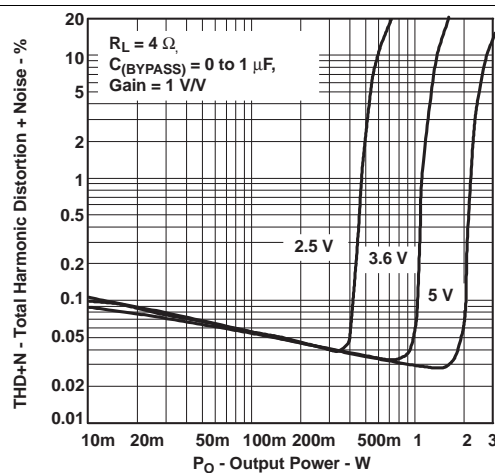
**Figure 3. Power Dissipation vs Output Power**



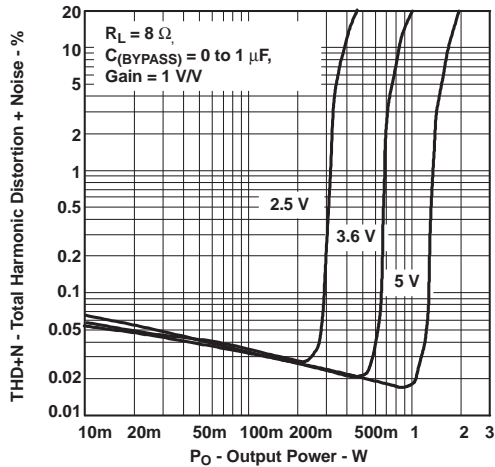
**Figure 4. Power Dissipation vs Output Power**



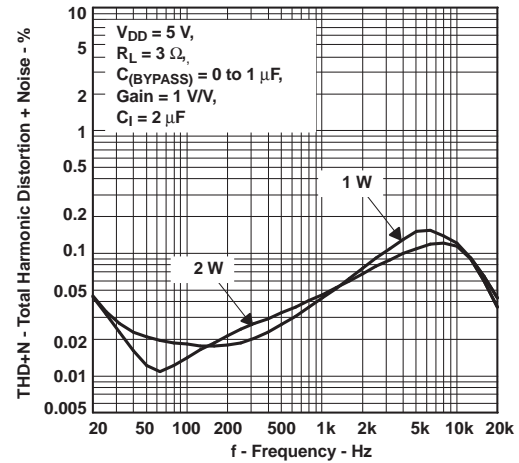
**Figure 5. Total Harmonic Distortion + Noise vs Output Power**



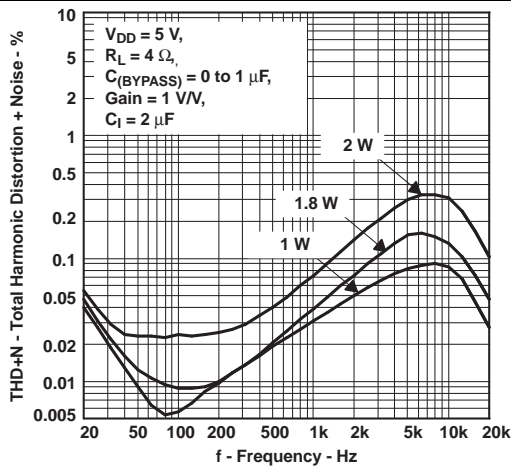
**Figure 6. Total Harmonic Distortion + Noise vs Output Power**



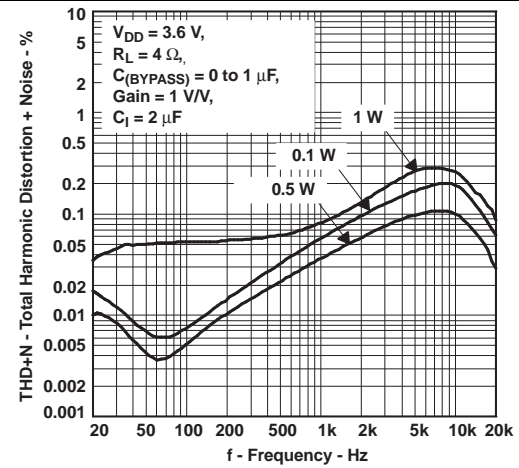
**Figure 7. Total Harmonic Distortion + Noise vs Output Power**



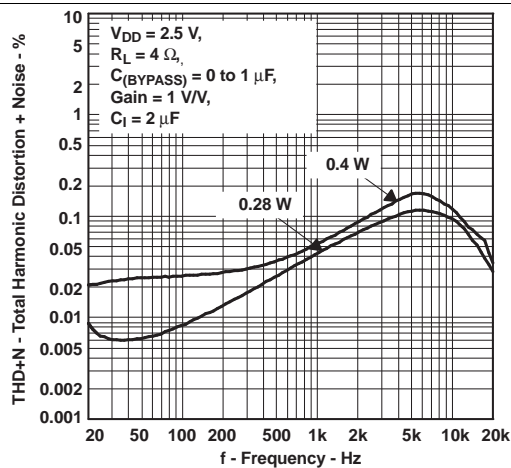
**Figure 8. Total Harmonic Distortion + Noise vs Frequency**



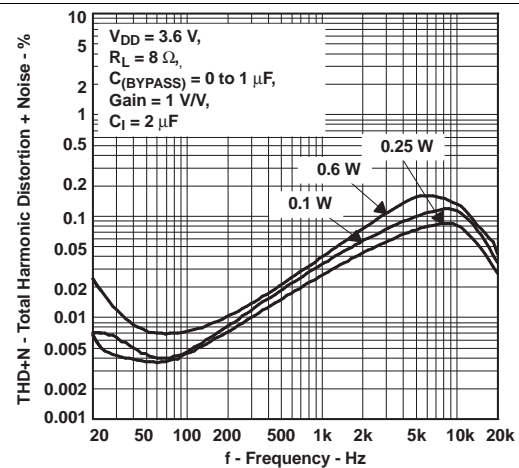
**Figure 9. Total Harmonic Distortion + Noise vs Frequency**



**Figure 10. Total Harmonic Distortion + Noise vs Frequency**

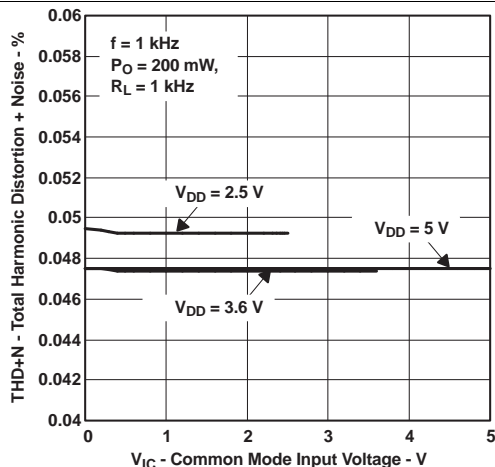


**Figure 11. Total Harmonic Distortion + Noise vs Frequency**

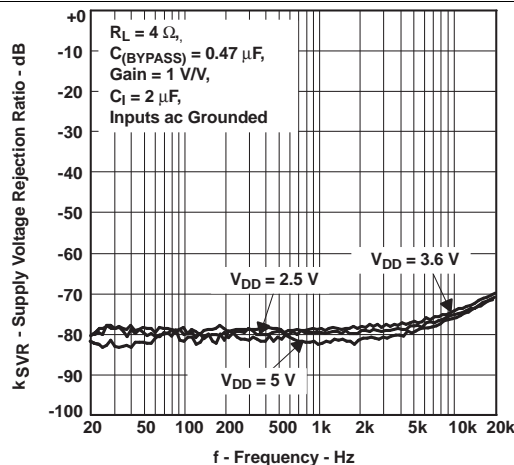


**Figure 12. Total Harmonic Distortion + Noise vs Frequency**

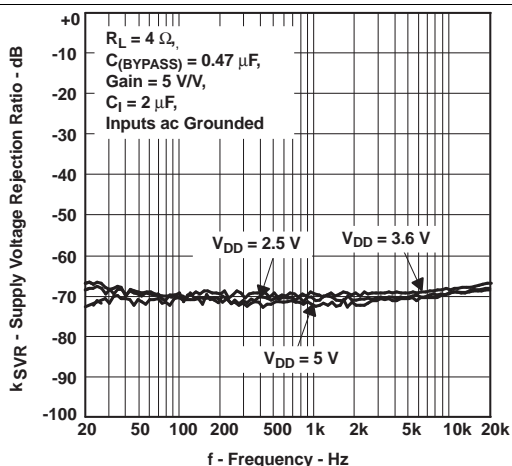




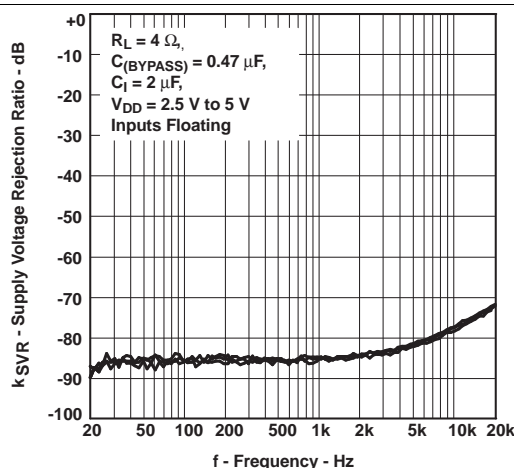
**Figure 13. Total Harmonic Distortion + Noise vs Common Mode Input Voltage**



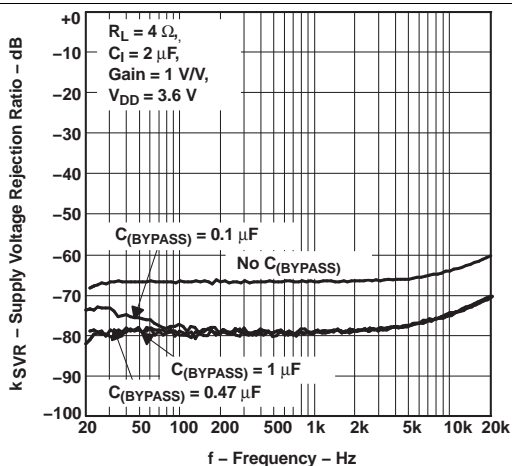
**Figure 14. Supply Voltage Rejection Ratio vs Frequency**



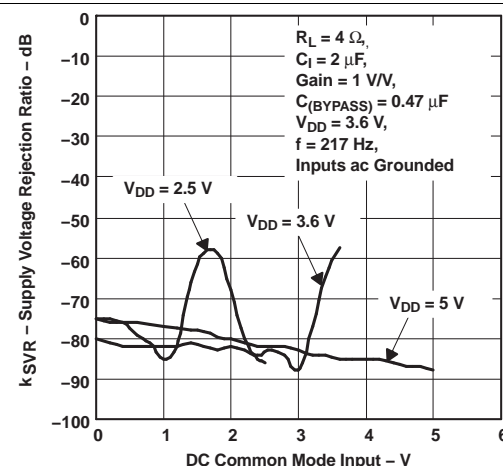
**Figure 15. Supply Voltage Rejection Ratio vs Frequency**



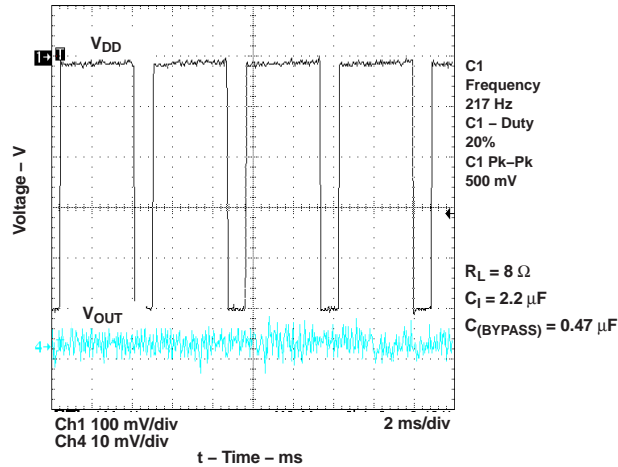
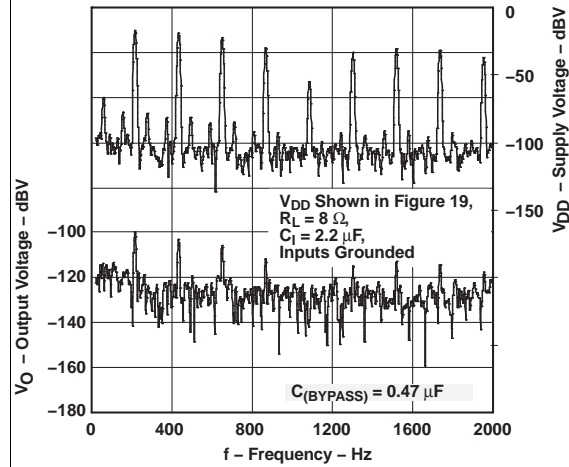
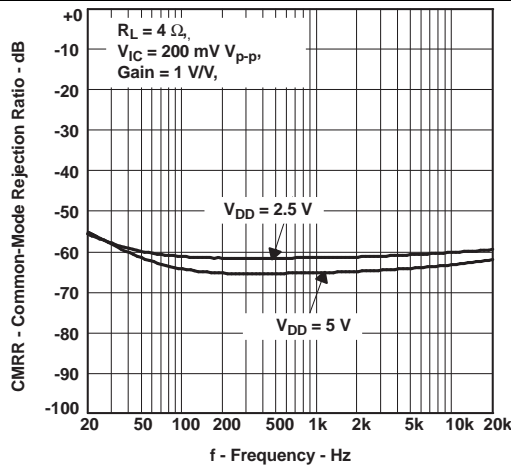
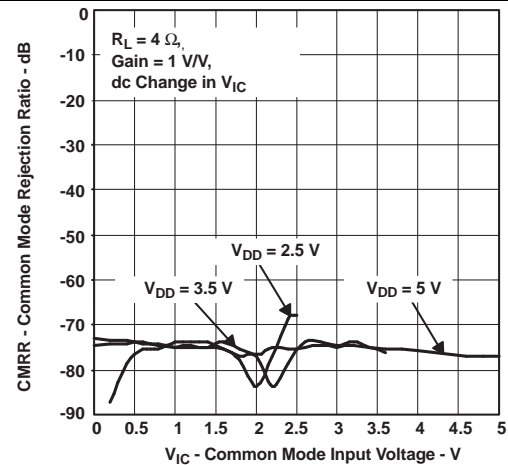
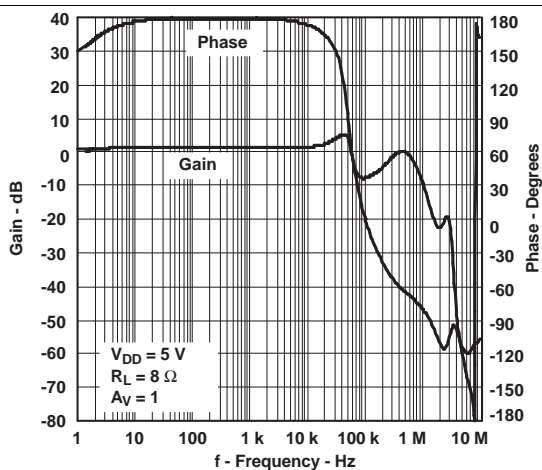
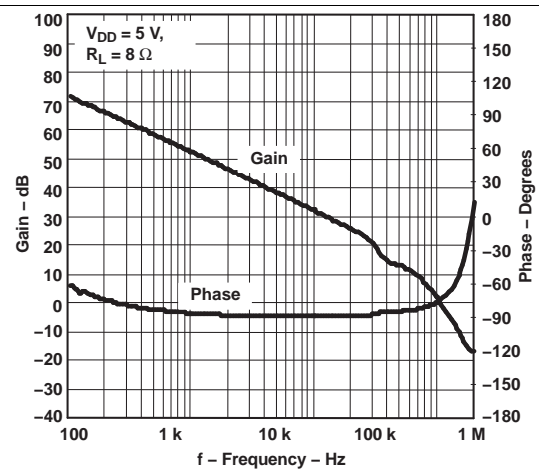
**Figure 16. Supply Voltage Rejection Ratio vs Frequency**



**Figure 17. Supply Voltage Rejection Ratio vs Frequency**



**Figure 18. Supply Voltage Rejection Ratio vs DC Common Mode Input**


**Figure 19. GSM Power Supply Rejection vs Time**

**Figure 20. GSM Power Supply Rejection vs Frequency**

**Figure 21. Common Mode Rejection Ratio vs Frequency**

**Figure 22. Common-Mode Rejection Ratio vs Common-Mode Input Voltage**

**Figure 23. Closed Loop Gain/Phase vs Frequency**

**Figure 24. Open Loop Gain/Phase vs Frequency**

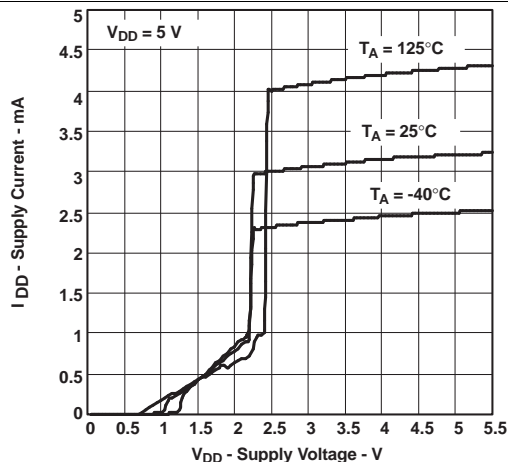


Figure 25. Supply Current vs Supply Voltage

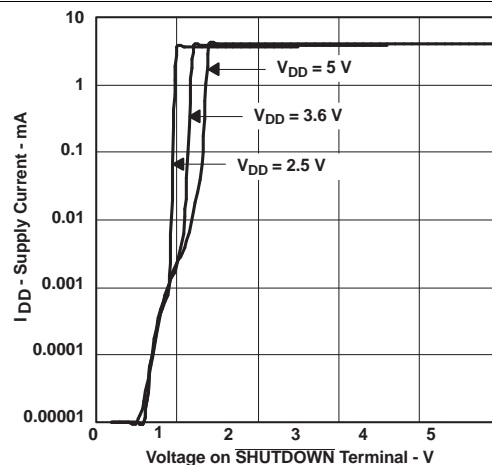


Figure 26. Supply Current vs Shutdown Voltage

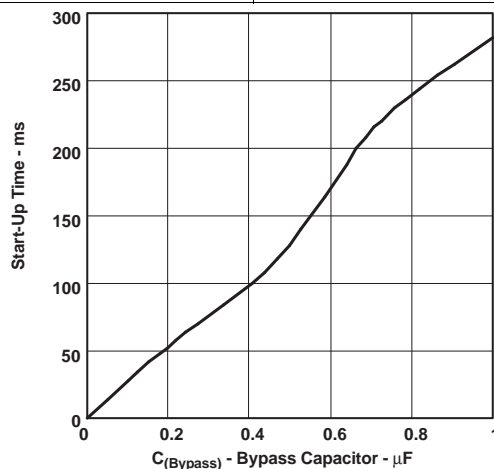


Figure 27. Start-Up Time vs Bypass Capacitor

## 8 Parameter Measurement Information

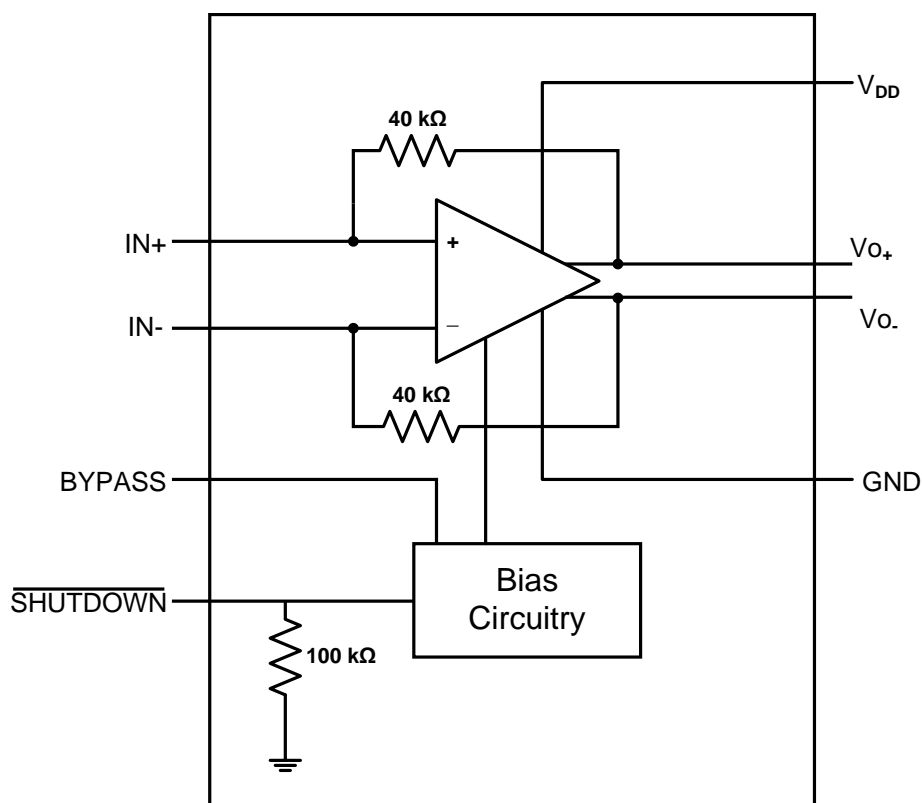
All parameters are measured according to the conditions described in [Specifications](#) section.

## 9 Detailed Description

### 9.1 Overview

The TPA6211A1 is a fully differential amplifier with differential inputs and outputs. The fully differential amplifier consists of a differential amplifier and a common-mode amplifier. The differential amplifier ensures that the amplifier outputs a differential voltage that is equal to the differential input times the gain. The common-mode feedback ensures that the common-mode voltage at the output is biased around  $V_{DD}/2$  regardless of the common-mode voltage at the input.

### 9.2 Functional Block Diagram



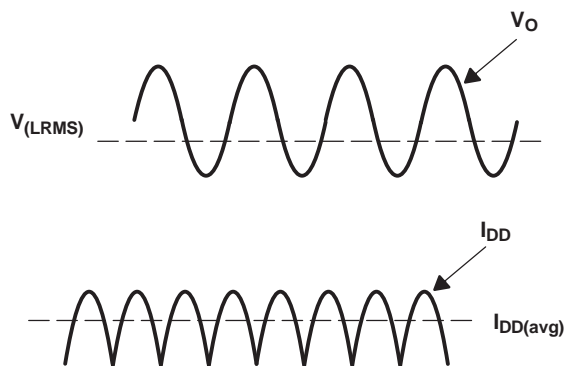
### 9.3 Feature Description

#### 9.3.1 Fully Differential Amplifier Efficiency and Thermal Information

Class-AB amplifiers are inefficient, primarily because of voltage drop across the output-stage transistors. The two components of this internal voltage drop are the headroom or dc voltage drop that varies inversely to output power, and the sinewave nature of the output. The total voltage drop can be calculated by subtracting the RMS value of the output voltage from  $V_{DD}$ . The internal voltage drop multiplied by the average value of the supply current,  $I_{DD}(\text{avg})$ , determines the internal power dissipation of the amplifier.

An easy-to-use equation to calculate efficiency starts out as being equal to the ratio of power from the power supply to the power delivered to the load. To accurately calculate the RMS and average values of power in the load and in the amplifier, the current and voltage waveform shapes must first be understood (see [Figure 28](#)).

## Feature Description (continued)



**Figure 28. Voltage and Current Waveforms for BTL Amplifiers**

Although the voltages and currents for SE and BTL are sinusoidal in the load, currents from the supply are different between SE and BTL configurations. In an SE application the current waveform is a half-wave rectified shape, whereas in BTL it is a full-wave rectified waveform. This means RMS conversion factors are different. Keep in mind that for most of the waveform both the push and pull transistors are not on at the same time, which supports the fact that each amplifier in the BTL device only draws current from the supply for half the waveform. The following equations are the basis for calculating amplifier efficiency.

These definitions are true for the following equations:

- $\eta_{\text{BTL}}$  = Efficiency of a BTL amplifier
- $P_L$  = Power delivered to load
- $P_{\text{SUP}}$  = Power drawn from power supply
- $V_{\text{LRMS}}$  = RMS voltage on BTL load
- $V_P$  = Peak voltage on BTL load
- $V_{\text{DD}}$  = Power supply voltage
- $I_{\text{DDavg}}$  = Average current drawn from the power supply

Use [Equation 1](#) to calculate the efficiency of a BTL amplifier.

$$\eta_{\text{BTL}} = \frac{P_L}{P_{\text{SUP}}}$$

where

$$\begin{aligned} & \bullet \quad P_L = \frac{V_{\text{LRMS}}^2}{R_L} \\ & \quad \text{where} \\ & \quad V_{\text{LRMS}} = \frac{V_P}{\sqrt{2}} \\ & \quad \text{therefore} \\ & \quad P_L = \frac{V_P^2}{2R_L} \\ & \bullet \quad P_{\text{SUP}} = V_{\text{DD}} I_{\text{DDavg}} \\ & \quad \text{where} \\ & \quad I_{\text{DDavg}} = \frac{1}{\pi} \int_0^\pi \frac{V_P}{R_L} \sin(t) dt = -\frac{1}{\pi} \times \frac{V_P}{R_L} [\cos(t)]_0^\pi = \frac{2V_P}{\pi R_L} \\ & \quad \text{therefore} \\ & \quad P_{\text{SUP}} = \frac{2V_{\text{DD}} V_P}{\pi R_L} \end{aligned} \tag{1}$$

## Feature Description (continued)

Using these values, substitute  $P_L$  and  $P_{SUP}$  from Equation 1 as shown in Equation 2.

$$\eta_{BTL} = \frac{\frac{V_P^2}{2R_L}}{\frac{2V_{DD}V_P}{\pi R_L}} = \frac{\pi V_P}{4V_{DD}}$$

where

$$\bullet V_P = \sqrt{2P_L R_L} \quad (2)$$

Therefore,  $\eta_{BTL}$  can be calculated using Equation 3.

$$\eta_{BTL} = \frac{\pi \sqrt{2P_L R_L}}{4V_{DD}} \quad (3)$$

**Table 2. Efficiency and Maximum Ambient Temperature vs Output Power**

OUTPUT POWER (W)	EFFICIENCY (%)	INTERNAL DISSIPATION (W)	POWER FROM SUPPLY (W)	MAX AMBIENT TEMPERATURE <sup>(1)</sup> (°C)
<b>5-V, 3-Ω Systems</b>				
0.5	27.2	1.34	1.84	85 <sup>(2)</sup>
1	38.4	1.6	2.6	76
2.45	60.2	1.62	4.07	75
3.1	67.7	1.48	4.58	82
<b>5-V, 4-Ω BTL Systems</b>				
0.5	31.4	1.09	1.59	85 <sup>(2)</sup>
1	44.4	1.25	2.25	85 <sup>(2)</sup>
2	62.8	1.18	3.18	85 <sup>(2)</sup>
2.8	74.3	0.97	3.77	85 <sup>(2)</sup>
<b>5-V, 8-Ω Systems</b>				
0.5	44.4	0.625	1.13	85 <sup>(2)</sup>
1	62.8	0.592	1.6	85 <sup>(2)</sup>
1.36	73.3	0.496	1.86	85 <sup>(2)</sup>
1.7	81.9	0.375	2.08	85 <sup>(2)</sup>

(1) DRB package

(2) Package limited to 85°C ambient

Table 2 uses Equation 3 to calculate efficiencies for four different output power levels. Note that the efficiency of the amplifier is quite low for lower power levels and rises sharply as power to the load is increased resulting in a nearly flat internal power dissipation over the normal operating range. Note that the internal dissipation at full output power is less than in the half power range. Calculating the efficiency for a specific system is the key to proper power supply design. For a 2.8-W audio system with 4-Ω loads and a 5-V supply, the maximum draw on the power supply is almost 3.8 W.

A final point to remember about Class-AB amplifiers is how to manipulate the terms in the efficiency equation to the utmost advantage when possible. Note that in Equation 3,  $V_{DD}$  is in the denominator. This indicates that as  $V_{DD}$  goes down, efficiency goes up.

Use Equation 4 as a simple formula for calculating the maximum power dissipated,  $P_{Dmax}$ , for a differential output application.

$$P_{Dmax} = \frac{2V_{DD}^2}{\pi^2 R_L}$$

where

- $P_{Dmax}$  for a 5-V, 4-Ω system is 1.27 W. (4)

The maximum ambient temperature depends on the heat sinking ability of the PCB system. The derating factor for the 3 mm x3 mm DRB package is shown in the dissipation rating table. Converting this to  $\theta_{JA}$ :

$$\theta_{JA} = \frac{1}{\text{Derating Factor}} = \frac{1}{0.0218} = 45.9^{\circ}\text{C} / \text{W} \quad (5)$$

Given  $\theta_{JA}$ , the maximum allowable junction temperature, and the maximum internal dissipation, the maximum ambient temperature can be calculated with Equation 6. The maximum recommended junction temperature for the TPA6211A1 is 150°C.

$$T_{A\text{Max}} = T_{J\text{Max}} - \theta_{JA} P_{Dmax} = 150 - 45.9(1.27) = 91.7^{\circ}\text{C} \quad (6)$$

Equation 6 shows that the maximum ambient temperature is 91.7°C (package limited to 85°C ambient) at maximum power dissipation with a 5-V supply.

Table 2 shows that for most applications no airflow is required to keep junction temperatures in the specified range. The TPA6211A1 is designed with thermal protection that turns the device off when the junction temperature surpasses 150°C to prevent damage to the IC. In addition, using speakers with an impedance higher than 4-Ω dramatically increases the thermal performance by reducing the output current.

### 9.3.1.1 Advantages of Fully Differential Amplifiers

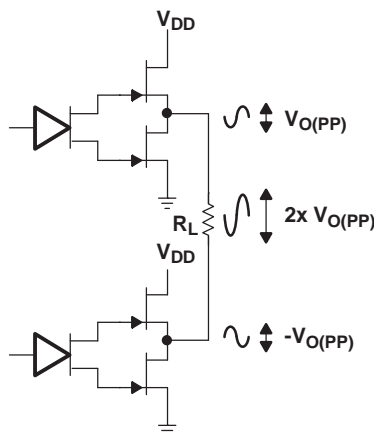
- **Input coupling capacitors not required:** A fully differential amplifier with good CMRR, like the TPA6211A1, allows the inputs to be biased at voltage other than mid-supply. For example, if a DAC has a lower mid-supply voltage than that of the TPA6211A1, the common-mode feedback circuit compensates, and the outputs are still biased at the mid-supply point of the TPA6211A1. The inputs of the TPA6211A1 can be biased from 0.5 V to  $V_{DD} - 0.8$  V. If the inputs are biased outside of that range, input coupling capacitors are required.
- **Mid-supply bypass capacitor,  $C_{(BYPASS)}$ , not required:** The fully differential amplifier does not require a bypass capacitor. Any shift in the mid-supply voltage affects both positive and negative channels equally, thus canceling at the differential output. Removing the bypass capacitor slightly worsens power supply rejection ratio ( $k_{SVR}$ ), but a slight decrease of  $k_{SVR}$  may be acceptable when an additional component can be eliminated (See Figure 17).
- **Better RF-immunity:** GSM handsets save power by turning on and shutting off the RF transmitter at a rate of 217 Hz. The transmitted signal is picked-up on input and output traces. The fully differential amplifier cancels the signal much better than the typical audio amplifier.
- Figure 31 through Figure 38 show application schematics for differential and single-ended inputs.

### 9.3.1.2 Differential Output Versus Single-Ended Output

Figure 29 shows a Class-AB audio power amplifier (APA) in a fully differential configuration. The TPA6211A1 amplifier has differential outputs driving both ends of the load. One of several potential benefits to this configuration is power to the load. The differential drive to the speaker means that as one side is slewing up, the other side is slewing down, and vice versa. This in effect doubles the voltage swing on the load as compared to a ground-referenced load. Plugging  $2 \times V_{O(PP)}$  into the power equation, where voltage is squared, yields 4x the output power from the same supply rail and load impedance Equation 7.

$$V_{(rms)} = \frac{V_{O(PP)}}{2\sqrt{2}}$$

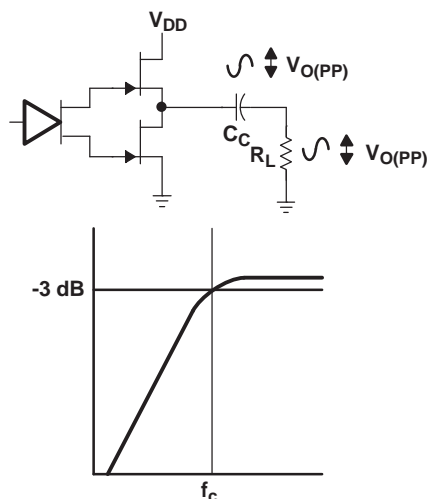
$$\text{Power} = \frac{V_{(rms)}^2}{R_L} \quad (7)$$


**Figure 29. Differential Output Configuration**

In a typical wireless handset operating at 3.6 V, bridging raises the power into an 8-Ω speaker from a singled-ended (SE, ground reference) limit of 200 mW to 800 mW. This is a 6-dB improvement in sound power—loudness that can be heard. In addition to increased power, there are frequency-response concerns. Consider the single-supply SE configuration shown in [Figure 30](#). A coupling capacitor ( $C_C$ ) is required to block the dc-offset voltage from the load. This capacitor can be quite large (approximately 33 μF to 1000 μF) so it tends to be expensive, heavy, occupy valuable PCB area, and have the additional drawback of limiting low-frequency performance. This frequency-limiting effect is due to the high-pass filter network created with the speaker impedance and the coupling capacitance. This is calculated with [Equation 8](#).

$$f_c = \frac{1}{2\pi R_L C_C} \quad (8)$$

For example, a 68-μF capacitor with an 8-Ω speaker would attenuate low frequencies below 293 Hz. The BTL configuration cancels the dc offsets, which eliminates the need for the blocking capacitors. Low-frequency performance is then limited only by the input network and speaker response. Cost and PCB space are also minimized by eliminating the bulky coupling capacitor.


**Figure 30. Single-Ended Output and Frequency Response**

Increasing power to the load does carry a penalty of increased internal power dissipation. The increased dissipation is understandable considering that the BTL configuration produces 4× the output power of the SE configuration.



## 9.4 Device Functional Modes

### 9.4.1 Shutdown Mode

The TPA6211A1 device can be put in shutdown mode when asserting SHUTDOWN pin to a logic LOW. While in shutdown mode, the device output stage is turned off and set into high impedance, making the current consumption very low. The device exits shutdown mode when a HIGH logic level is applied to SHUTDOWN pin.

## 10 Application and Implementation

### NOTE

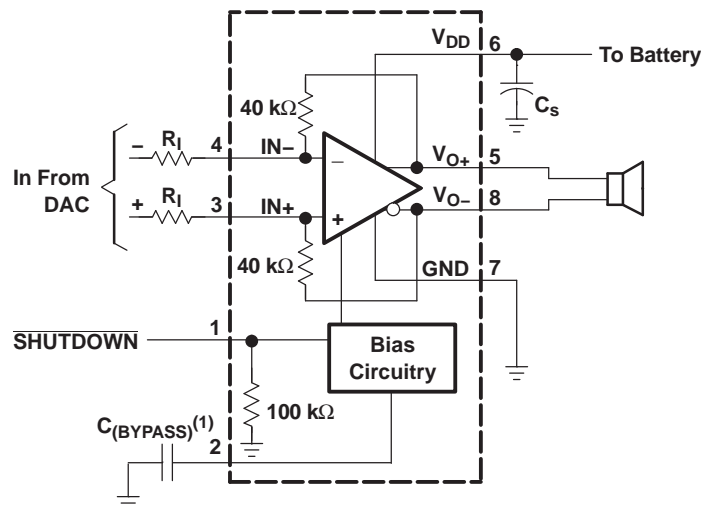
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 10.1 Application Information

The TPA6211A1 is a fully-differential amplifier designed to drive a speaker with at least 3-Ω impedance while consuming only 20 mm<sup>2</sup> total printed circuit board (PCB) area in most applications.

### 10.2 Typical Application

Figure 31 shows a typical application circuit for the TPA6211A1 with a speaker, input resistors and supporting power supply decoupling capacitors.



<sup>(1)</sup> C<sub>(BYPASS)</sub> is optional

**Figure 31. Typical Differential Input Application Schematic**

Typical values are shown in Table 3.

**Table 3. Typical Component Values**

COMPONENT	VALUE
R <sub>I</sub>	40 kΩ
C <sub>(BYPASS)</sub> <sup>(1)</sup>	0.22 μF
C <sub>S</sub>	1 μF
C <sub>I</sub>	0.22 μF

<sup>(1)</sup> C<sub>(BYPASS)</sub> is optional.

## 10.2.1 Design Requirements

For this design example, use the parameters listed in [Table 4](#).

**Table 4. Design Parameters**

DESIGN PARAMETER	EXAMPLE VALUE
Power supply	2.5 V to 5.5 V
Current	4 mA to 5 mA
Shutdown	High > 1.55 V
	Low < 0.5 V
Speaker	3 Ω, 4 Ω, or 8 Ω

## 10.2.2 Detailed Design Procedure

### 10.2.2.1 Selecting Components

#### 10.2.2.1.1 Resistors ( $R_I$ )

The input resistor ( $R_I$ ) can be selected to set the gain of the amplifier according to [Equation 9](#).

$$\text{Gain} = \frac{R_F}{R_I} \quad (9)$$

The internal feedback resistors ( $R_F$ ) are trimmed to 40 kΩ.

Resistor matching is very important in fully differential amplifiers. The balance of the output on the reference voltage depends on matched ratios of the resistors. CMRR, PSRR, and the cancellation of the second harmonic distortion diminishes if resistor mismatch occurs. Therefore, 1%-tolerance resistors or better are recommended to optimize performance.

#### 10.2.2.1.2 Bypass Capacitor ( $C_{\text{BYPASS}}$ ) and Start-Up Time

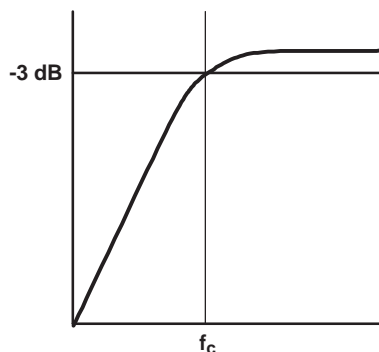
The internal voltage divider at the BYPASS pin of this device sets a mid-supply voltage for internal references and sets the output common mode voltage to  $V_{\text{DD}}/2$ . Adding a capacitor filters any noise into this pin, increasing  $k_{\text{SVR}}$ .  $C_{\text{BYPASS}}$  also determines the rise time of  $V_{\text{O+}}$  and  $V_{\text{O-}}$  when the device exits shutdown. The larger the capacitor, the slower the rise time.

#### 10.2.2.1.3 Input Capacitor ( $C_I$ )

The TPA6211A1 does not require input coupling capacitors when driven by a differential input source biased from 0.5 V to  $V_{\text{DD}} - 0.8$  V. Use 1% tolerance or better gain-setting resistors if not using input coupling capacitors.

In the single-ended input application, an input capacitor,  $C_I$ , is required to allow the amplifier to bias the input signal to the proper dc level. In this case,  $C_I$  and  $R_I$  form a high-pass filter with the corner frequency defined in [Equation 10](#).

$$f_c = \frac{1}{2\pi R_I C_I} \quad (10)$$



**Figure 32. Input Filter Cutoff Frequency**

The value of  $C_I$  is an important consideration. It directly affects the bass (low frequency) performance of the circuit. Consider the example where  $R_I$  is 10 k $\Omega$  and the specification calls for a flat bass response down to 100 Hz. Equation 10 is reconfigured as Equation 11.

$$C_I = \frac{1}{2\pi R_I f_c} \quad (11)$$

In this example,  $C_I$  is 0.16  $\mu$ F, so the likely choice ranges from 0.22  $\mu$ F to 0.47  $\mu$ F. Ceramic capacitors are preferred because they are the best choice in preventing leakage current. When polarized capacitors are used, the positive side of the capacitor faces the amplifier input in most applications. The input dc level is held at  $V_{DD}/2$ , typically higher than the source dc level. It is important to confirm the capacitor polarity in the application.

#### 10.2.2.1.4 Band-Pass Filter ( $R_a$ , $C_a$ , and $C_a$ )

It may be desirable to have signal filtering beyond the one-pole high-pass filter formed by the combination of  $C_I$  and  $R_I$ . A low-pass filter may be added by placing a capacitor ( $C_F$ ) between the inputs and outputs, forming a band-pass filter.

An example of when this technique might be used would be in an application where the desirable pass-band range is between 100 Hz and 10 kHz, with a gain of 4 V/V. The following equations illustrate how the proper values of  $C_F$  and  $C_I$  can be determined.

##### 10.2.2.1.4.1 Step 1: Low-Pass Filter

$$f_{c(LPF)} = \frac{1}{2\pi R_F C_F} \quad (12)$$

where

- $R_F$  is the internal 40 k $\Omega$  resistor

$$f_{c(LPF)} = \frac{1}{2\pi 40\text{k}\Omega C_F} \quad (13)$$

Therefore,

$$C_F = \frac{1}{2\pi 40\text{k}\Omega f_{c(LPF)}} \quad (14)$$

Substitute  $f_{c(LPF)}$  with 10 kHz and solve for  $C_F$ :  $C_F = 398$  pF

##### 10.2.2.1.4.2 Step 2: High-Pass Filter

$$f_{c(HPF)} = \frac{1}{2\pi R_I C_I} \quad (15)$$

where

- $R_I$  is the input resistor

Because the application in this case requires a gain of 4 V/V,  $R_I$  must be set to 10 k $\Omega$ .

Substitute  $R_I$  in Equation 15 with 10 k $\Omega$  as shown in Equation 16.

$$f_{c(HPF)} = \frac{1}{2\pi 10\text{k}\Omega C_I} \quad (16)$$

Therefore,

$$C_I = \frac{1}{2\pi 10\text{k}\Omega f_{c(HPF)}} \quad (17)$$

Substitute  $f_{c(HPF)}$  with 100 Hz and solve for  $C_I$ :  $C_I = 0.16$   $\mu$ F

At this point, a first-order band-pass filter has been created with the low-frequency cutoff set to 100 Hz and the high-frequency cutoff set to 10 kHz.

The process can be taken a step further by creating a second-order high-pass filter. This is accomplished by placing a resistor ( $R_a$ ) and capacitor ( $C_a$ ) in the input path. It is important to note that  $R_a$  must be at least 10 times smaller than  $R_i$ ; otherwise its value has a noticeable effect on the gain, as  $R_a$  and  $R_i$  are in series.

#### 10.2.2.1.4.3 Step 3: Additional Low-Pass Filter

$R_a$  must be at least 10x smaller than  $R_i$ , Set  $R_a = 1 \text{ k}\Omega$ ,

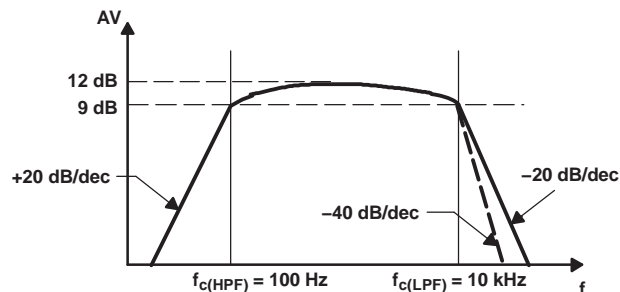
$$f_{c(\text{LPF})} = \frac{1}{2\pi R_a C_a} \quad (18)$$

Therefore,

$$C_a = \frac{1}{2\pi \cdot 1\text{k}\Omega \cdot f_{c(\text{LPF})}} \quad (19)$$

Substitute  $f_{c(\text{LPF})}$  with 10 kHz and solving for  $C_a$ :  $C_a = 160 \text{ pF}$

Figure 33 is a bode plot for the band-pass filter in the previous example. Figure 38 shows how to configure the TPA6211A1 as a band-pass filter.



**Figure 33. Bode Plot**

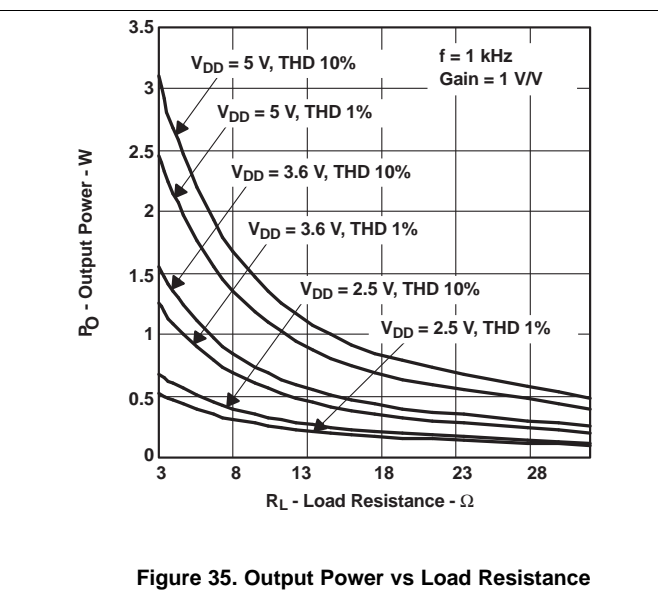
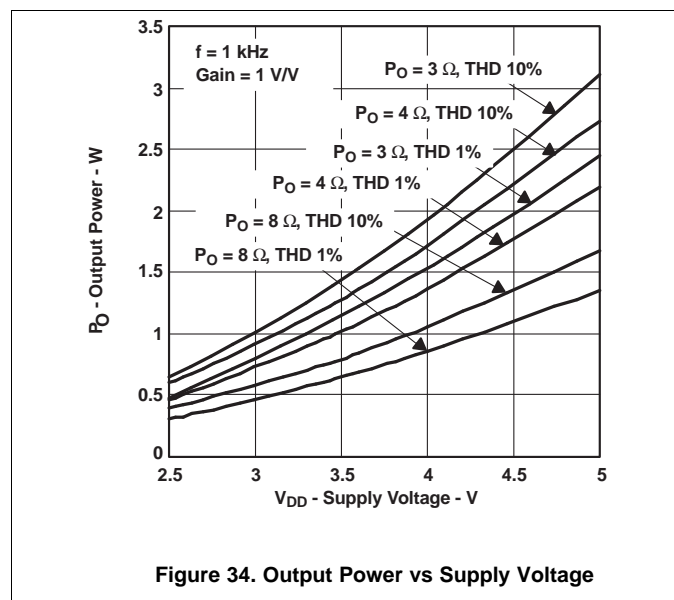
#### 10.2.2.1.5 Decoupling Capacitor ( $C_s$ )

The TPA6211A1 is a high-performance CMOS audio amplifier that requires adequate power supply decoupling to ensure the output total harmonic distortion (THD) is as low as possible. Power-supply decoupling also prevents oscillations for long lead lengths between the amplifier and the speaker. For higher frequency transients, spikes, or digital hash on the line, a good low equivalent-series-resistance (ESR) ceramic capacitor, typically 0.1  $\mu\text{F}$  to 1  $\mu\text{F}$ , placed as close as possible to the device  $V_{DD}$  lead works best. For filtering lower frequency noise signals, a 10- $\mu\text{F}$  or greater capacitor placed near the audio power amplifier also helps, but is not required in most applications because of the high PSRR of this device.

#### 10.2.2.1.6 Using Low-ESR Capacitors

Low-ESR capacitors are recommended throughout this application section. A real (as opposed to ideal) capacitor can be modeled simply as a resistor in series with an ideal capacitor. The voltage drop across this resistor minimizes the beneficial effects of the capacitor in the circuit. The lower the equivalent value of this resistance the more the real capacitor behaves like an ideal capacitor.

### 10.2.3 Application Curves



### 10.3 System Examples

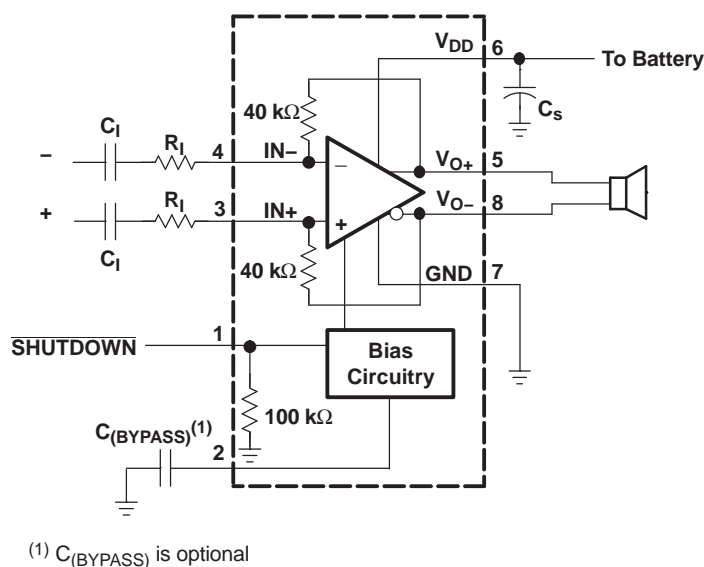
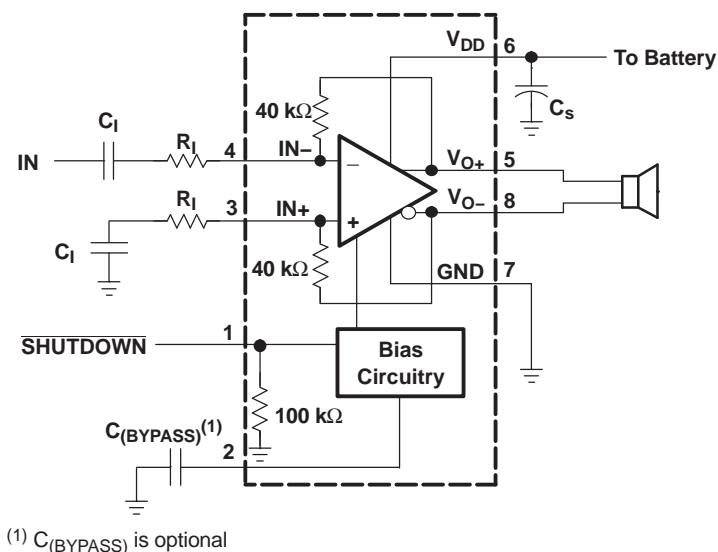
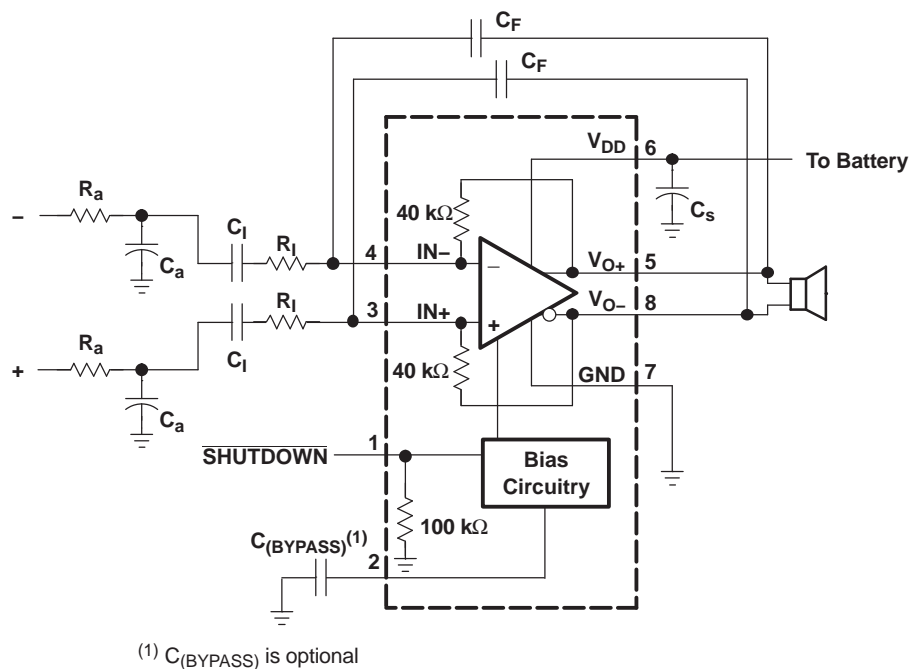


Figure 36. Differential Input Application Schematic Optimized With Input Capacitors

## System Examples (continued)



**Figure 37. Single-Ended Input Application Schematic**



**Figure 38. Differential Input Application Schematic With Input Bandpass Filter**

## 11 Power Supply Recommendations

The TPA6211A1 device is designed to operate from an input voltage supply range between 2.5 V and 5.5 V. Therefore, the output voltage range of power supply must be within this range and well regulated. The current capability of upper power should not exceed the maximum current limit of the power switch.

### 11.1 Power Supply Decoupling Capacitor

The TPA6211A1 device requires adequate power supply decoupling to ensure a high efficiency operation with low total harmonic distortion (THD).

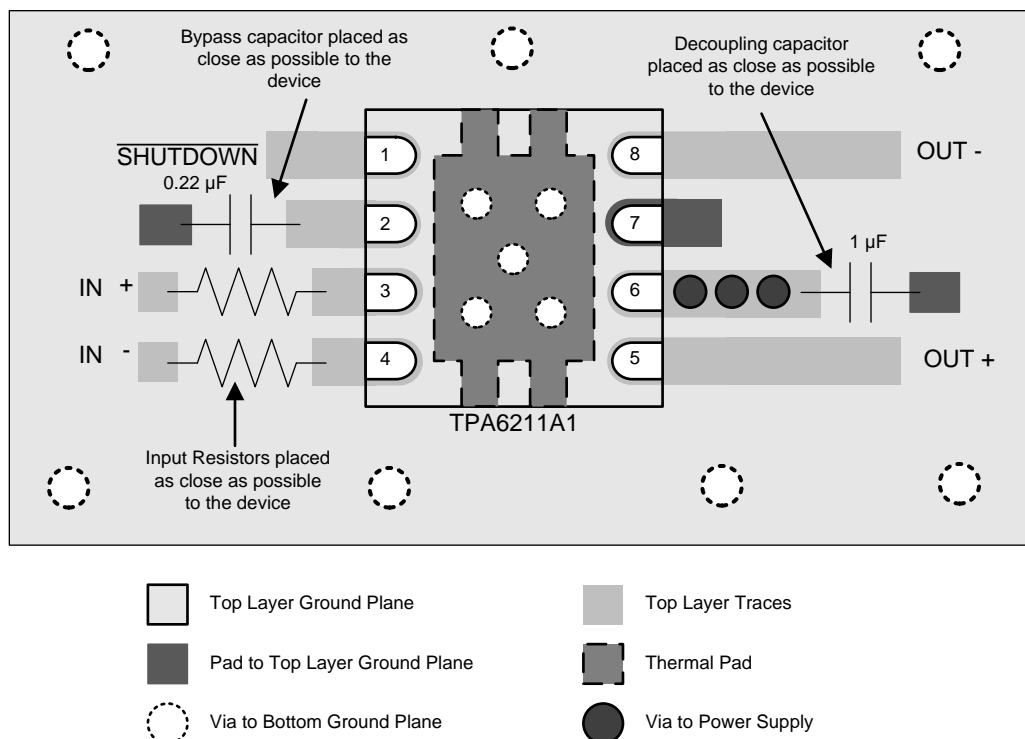
Place a low equivalent series resistance (ESR) ceramic capacitor, typically 0.1  $\mu\text{F}$ , as close as possible of the VDD pin. This choice of capacitor and placement helps with higher frequency transients, spikes, or digital hash on the line. Also is recommended to place a 2.2- $\mu\text{F}$  to 10- $\mu\text{F}$  capacitor on the VDD supply trace. This larger capacitor acts as a charge reservoir, providing energy faster than the board supply, thus helping to prevent any droop in the supply voltage.

## 12 Layout

### 12.1 Layout Guidelines

Place all the external components close to the TPA6211A1 device. The input resistors need to be close to the device input pins so noise does not couple on the high impedance nodes between the input resistors and the input amplifier of the device. Placing the decoupling capacitors,  $C_S$  and  $C_{\text{BYPASS}}$ , close to the TPA6211A1 device is important for the efficiency of the amplifier. Any resistance or inductance in the trace between the device and the capacitor can cause a loss in efficiency.

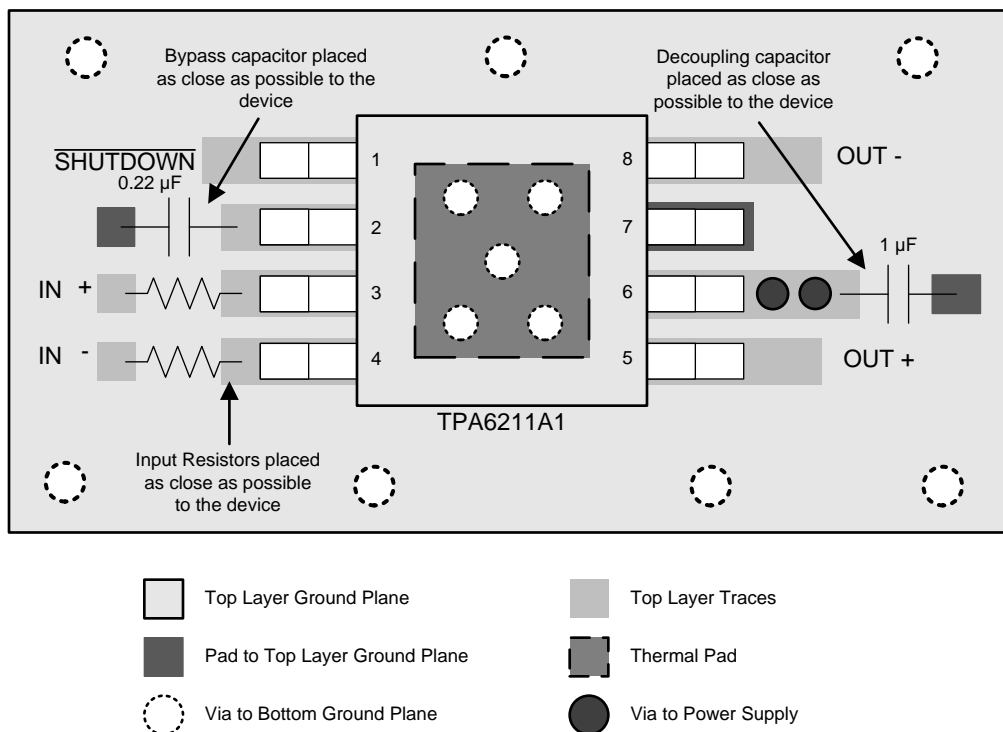
### 12.2 Layout Examples



**Figure 39. TPA6211A1 8-Pin SON (DRB) Board Layout**



## Layout Examples (continued)



**Figure 40. TPA6211A1 8-Pin MSOP-PowerPAD™ (DGN) Board Layout**

## 13 Device and Documentation Support

### 13.1 Device Support

#### 13.1.1 Development Support

For the TPA6211A1 TINA-TI Spice Model, see [SBOM819](#).

For the TPA6211A1 TINA-TI Reference Design, see [SBOM820](#).

For the TPA6211A1EVM Gerber files, see [SLOC009](#).

For the *Speaker Amplifier Class AB/Class D* Parametric Table, go to [www.ti.com/lscs/ti/audio-ic/speaker-amplifier-class-ab-class-d-product.page](http://www.ti.com/lscs/ti/audio-ic/speaker-amplifier-class-ab-class-d-product.page)

### 13.2 Documentation Support

#### 13.2.1 Related Documentation

For related documentation, see the following:

TPA6211A1EVM User's Guide, *TPA6211A1 Audio Power Amplifier Evaluation Module*, [SLOU162](#)

### 13.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

**TI E2E™ Online Community** *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At [e2e.ti.com](http://e2e.ti.com), you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

### 13.4 Trademarks

PowerPAD, E2E are trademarks of Texas Instruments.  
All other trademarks are the property of their respective owners.

### 13.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### 13.6 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
<a href="#">TPA6211A1DGN</a>	Active	Production	HVSSOP (DGN)   8	80   TUBE	Yes	NIPDAU   NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	AYK
TPA6211A1DGN.B	Active	Production	HVSSOP (DGN)   8	80   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AYK
TPA6211A1DGNG4	Active	Production	HVSSOP (DGN)   8	80   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AYK
<a href="#">TPA6211A1DGNR</a>	Active	Production	HVSSOP (DGN)   8	2500   LARGE T&R	Yes	NIPDAU   NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	AYK
TPA6211A1DGNR.B	Active	Production	HVSSOP (DGN)   8	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AYK
TPA6211A1DGNRG4	Active	Production	HVSSOP (DGN)   8	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AYK
<a href="#">TPA6211A1DRB</a>	Active	Production	SON (DRB)   8	121   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	AYN
TPA6211A1DRB.B	Active	Production	SON (DRB)   8	121   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	AYN
<a href="#">TPA6211A1DRBR</a>	Active	Production	SON (DRB)   8	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	AYN
TPA6211A1DRBR.B	Active	Production	SON (DRB)   8	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	AYN
TPA6211A1DRBRG4	Active	Production	SON (DRB)   8	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	AYN

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

**OTHER QUALIFIED VERSIONS OF TPA6211A1 :**

- Automotive : [TPA6211A1-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

## TAPE AND REEL INFORMATION



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPA6211A1DGNR	HVSSOP	DGN	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
TPA6211A1DGNR	HVSSOP	DGN	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
TPA6211A1DRBR	SON	DRB	8	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPA6211A1DRBR	SON	DRB	8	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPA6211A1DGNR	HVSSOP	DGN	8	2500	358.0	335.0	35.0
TPA6211A1DGNR	HVSSOP	DGN	8	2500	364.0	364.0	27.0
TPA6211A1DRBR	SON	DRB	8	3000	346.0	346.0	33.0
TPA6211A1DRBR	SON	DRB	8	3000	353.0	353.0	32.0

**TUBE**


\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
TPA6211A1DGN	DGN	HVSSOP	8	80	330	6.55	500	2.88
TPA6211A1DGN.B	DGN	HVSSOP	8	80	330	6.55	500	2.88
TPA6211A1DGNG4	DGN	HVSSOP	8	80	330	6.55	500	2.88
TPA6211A1DRB	DRB	VSON	8	121	381	4.82	2286	NA
TPA6211A1DRB	DRB	VSON	8	121	381	4.83	2286	0
TPA6211A1DRB.B	DRB	VSON	8	121	381	4.83	2286	0
TPA6211A1DRB.B	DRB	VSON	8	121	381	4.82	2286	NA

**DRB 8**

**GENERIC PACKAGE VIEW**

**VSON - 1 mm max height**

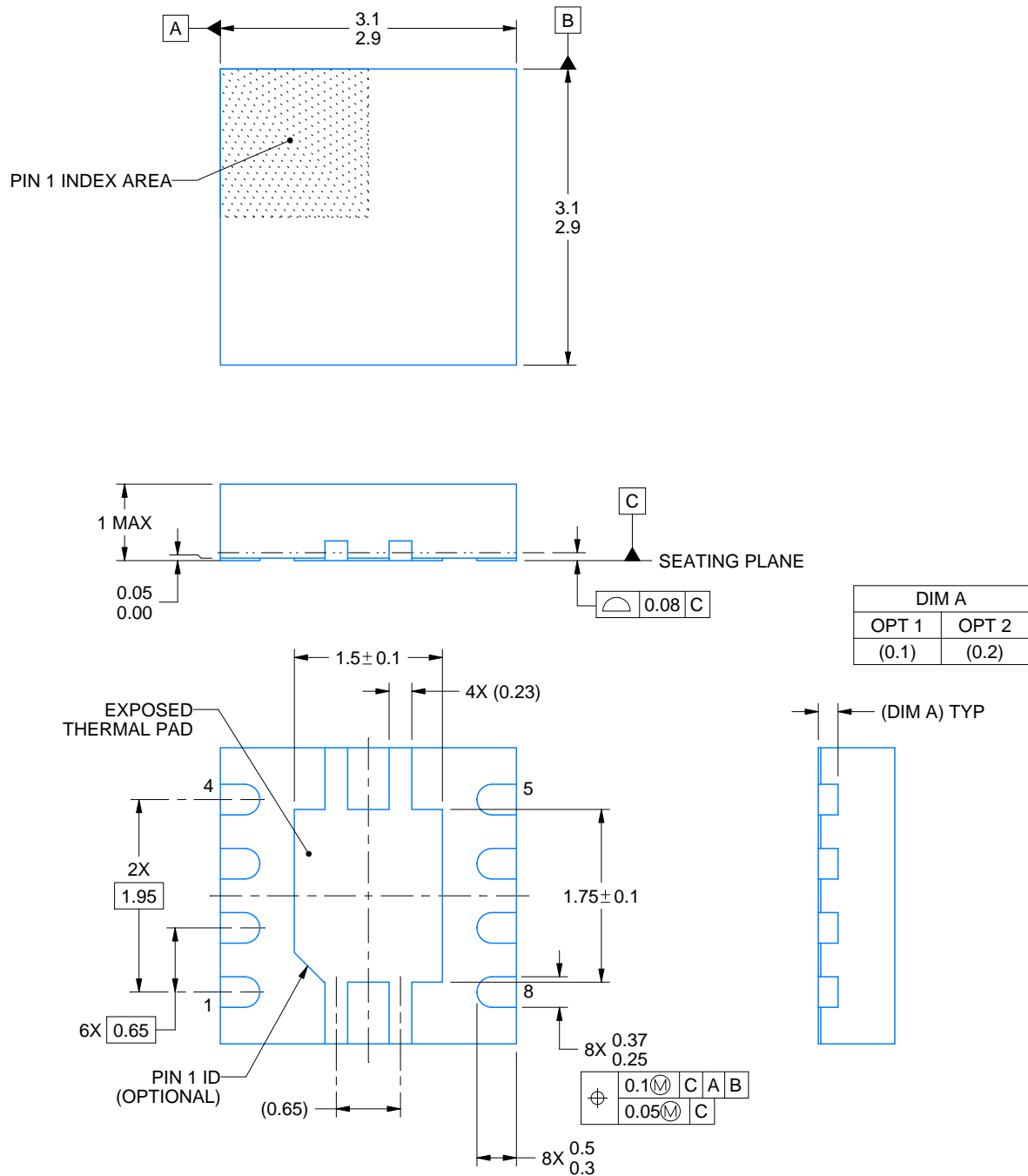
PLASTIC SMALL OUTLINE - NO LEAD



Images above are just a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.

4203482/L





4218875/A 01/2018

## NOTES:

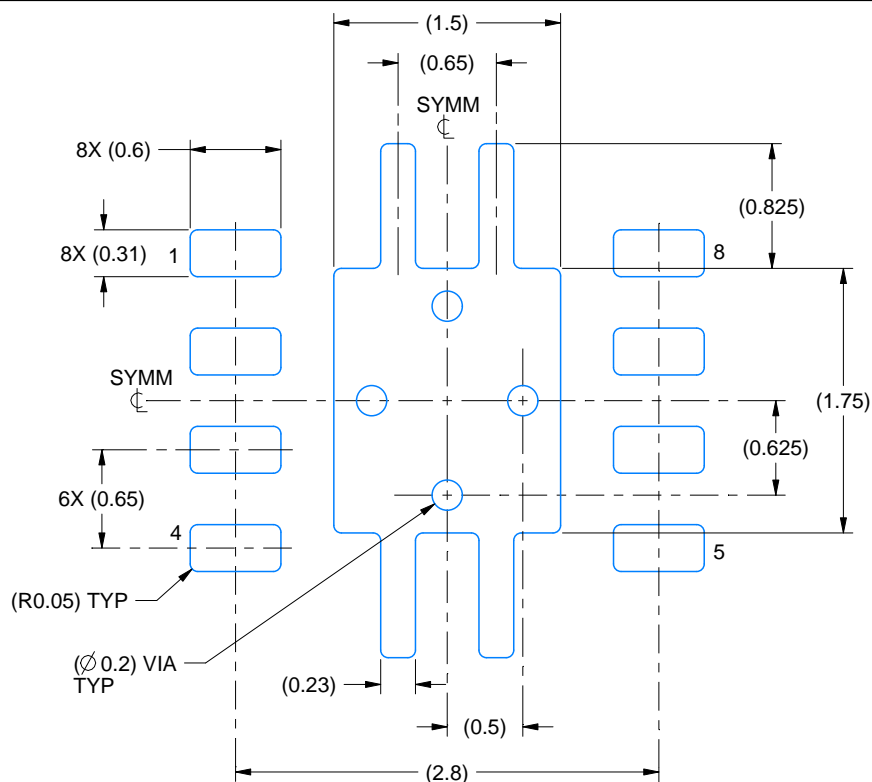
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

# EXAMPLE BOARD LAYOUT

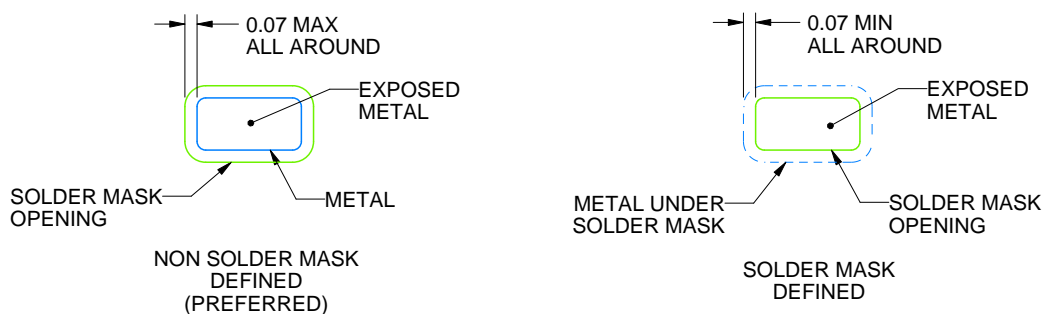
DRB0008A

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:20X



SOLDER MASK DETAILS

4218875/A 01/2018

NOTES: (continued)

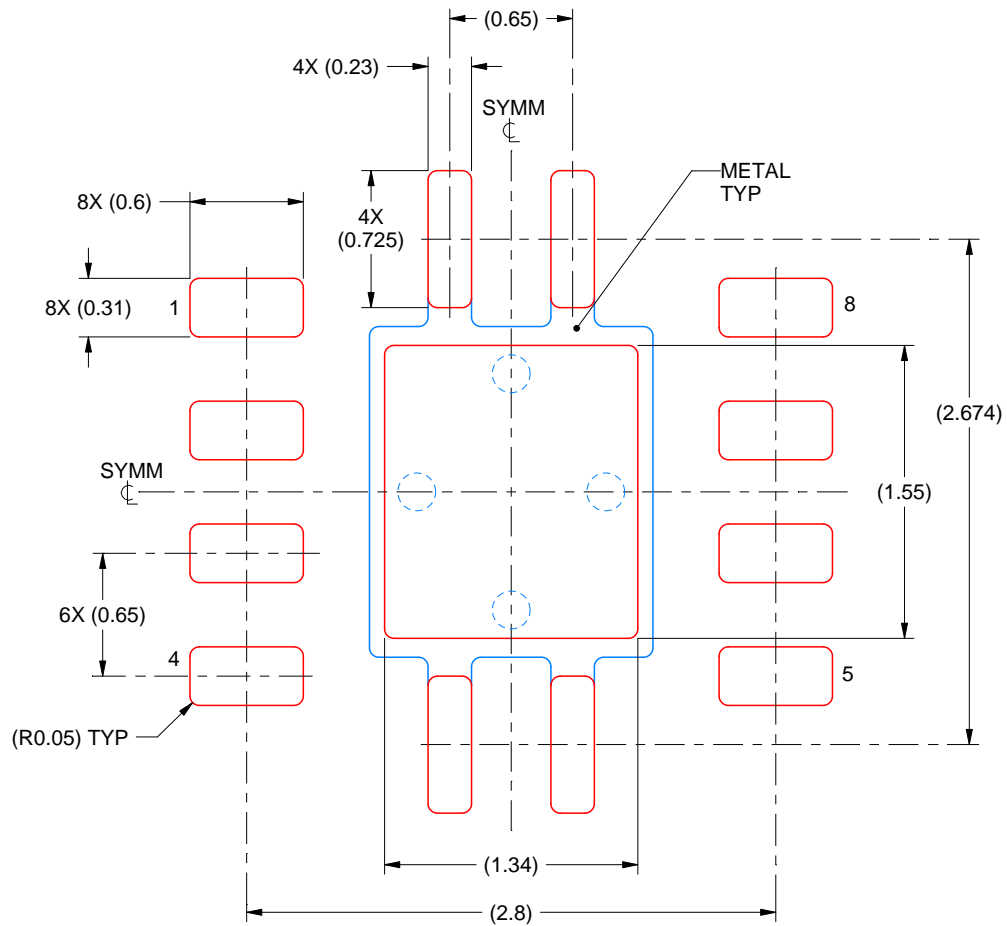
- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/sluea271](http://www.ti.com/lit/sluea271)).
- Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

# EXAMPLE STENCIL DESIGN

DRB0008A

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD  
84% PRINTED SOLDER COVERAGE BY AREA  
SCALE:25X

4218875/A 01/2018

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

## GENERIC PACKAGE VIEW

**DGN 8**

**PowerPAD™ HVSSOP - 1.1 mm max height**

**3 x 3, 0.65 mm pitch**

SMALL OUTLINE PACKAGE

This image is a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.



4225482/B



4225481/A 11/2019

## NOTES:

PowerPAD is a trademark of Texas Instruments.

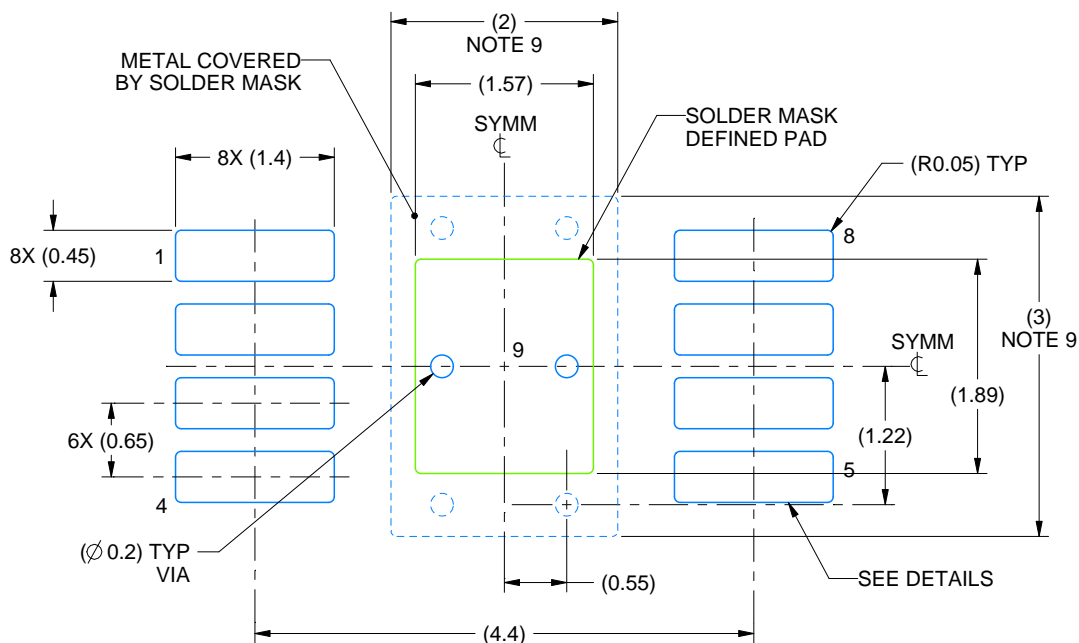
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187.

# EXAMPLE BOARD LAYOUT

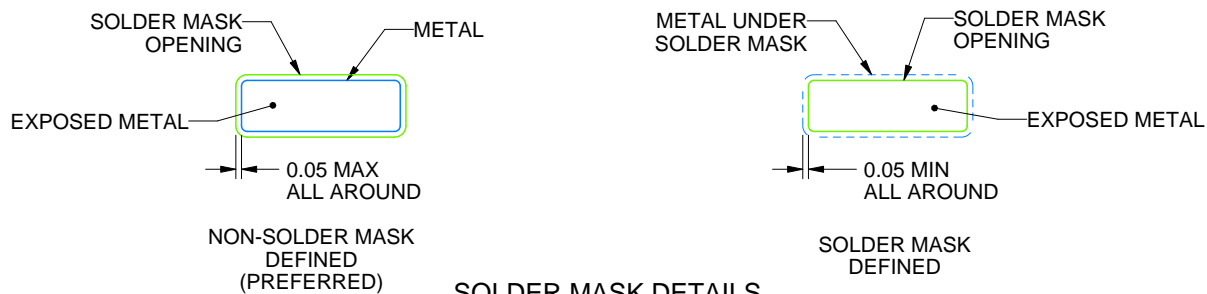
DGN0008D

PowerPAD™ VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 15X



SOLDER MASK DETAILS

4225481/A 11/2019

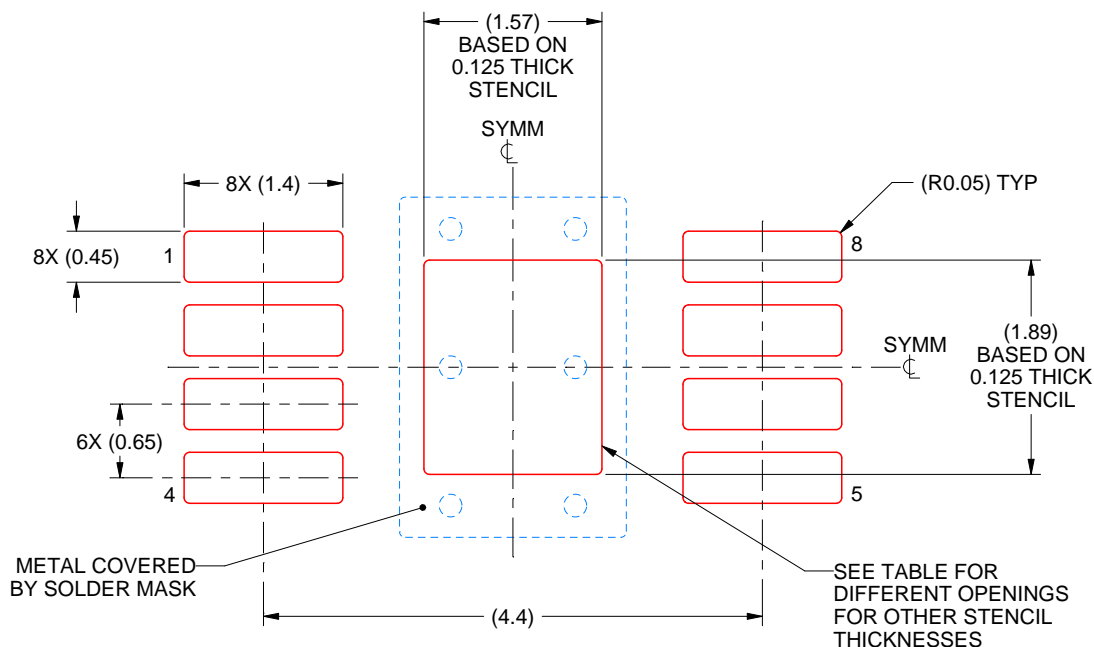
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
9. Size of metal pad may vary due to creepage requirement.

**DGN0008D**

# PowerPAD™ VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



## SOLDER PASTE EXAMPLE

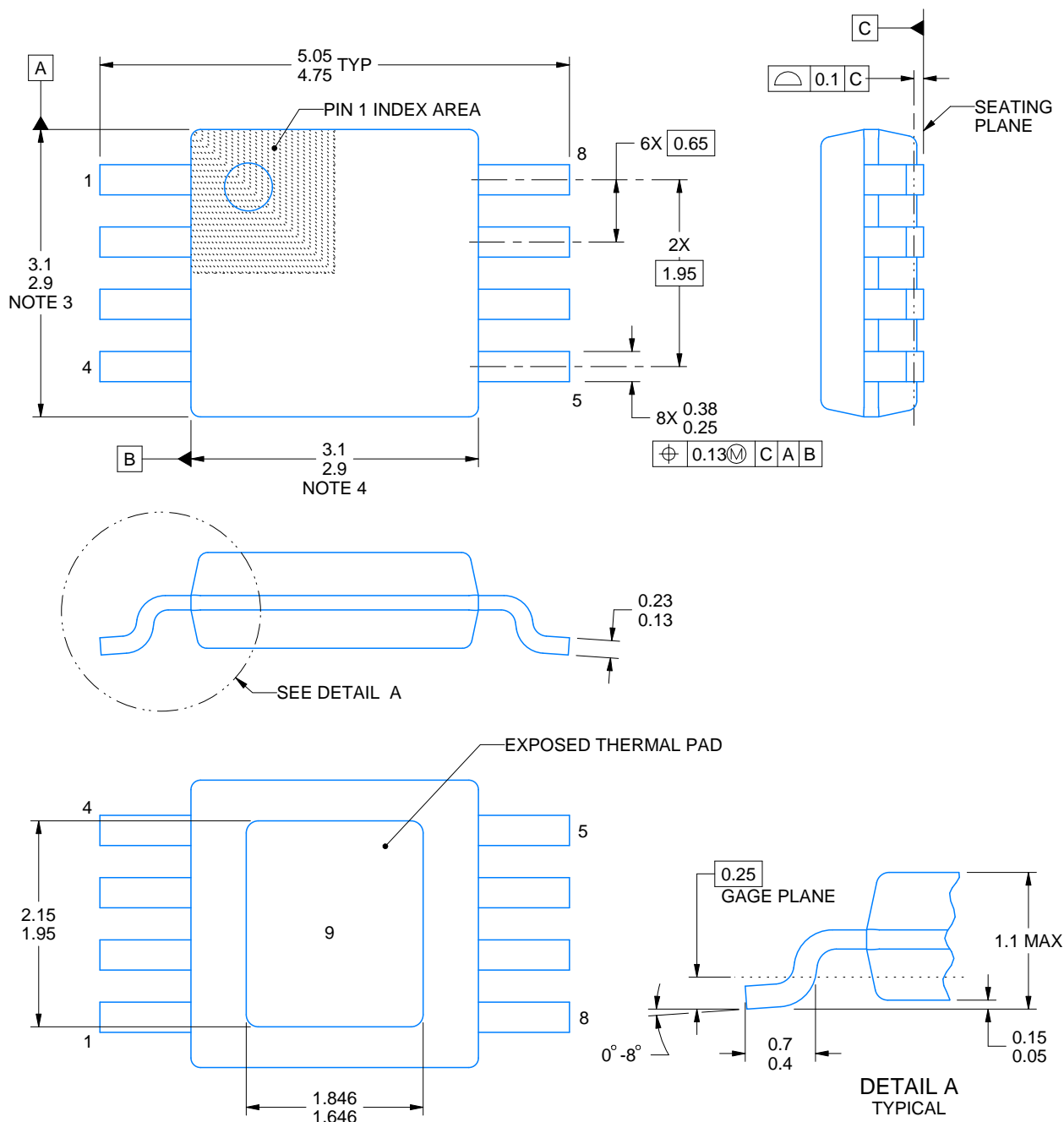
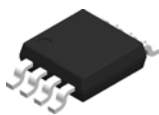
EXPOSED PAD 9:  
100% PRINTED SOLDER COVERAGE BY AREA  
SCALE: 15X

STENCIL THICKNESS	SOLDER STENCIL OPENING
0.1	1.76 X 2.11
0.125	1.57 X 1.89 (SHOWN)
0.15	1.43 X 1.73
0.175	1.33 X 1.60

4225481/A 11/2019

NOTES: (continued)

10. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
11. Board assembly site may have different recommendations for stencil design.



4225480/C 11/2024

## NOTES:

PowerPAD is a trademark of Texas Instruments.

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187.

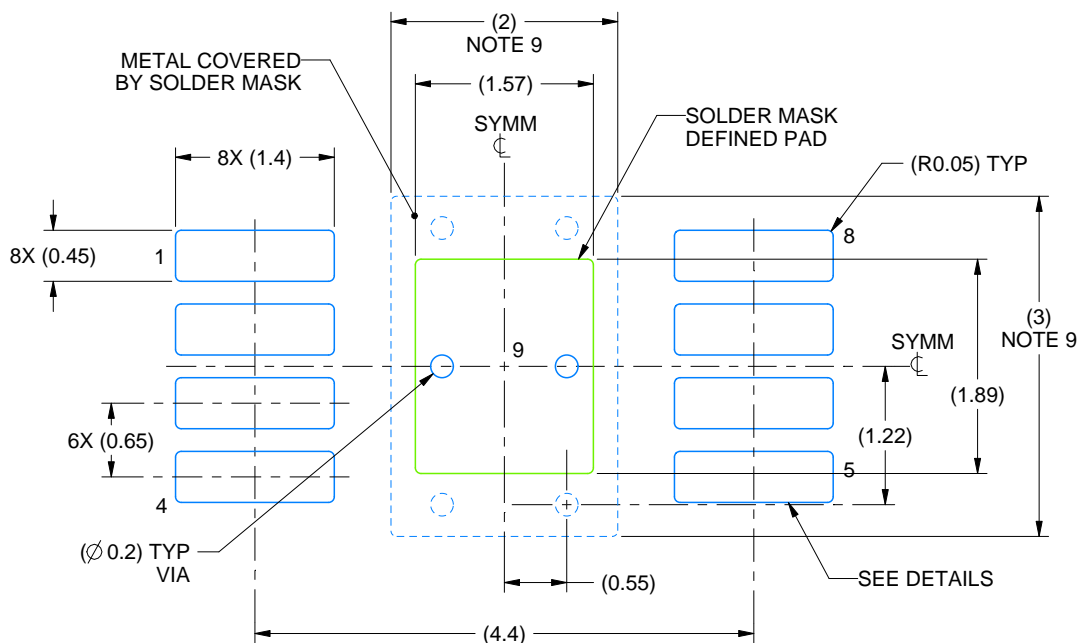


# EXAMPLE BOARD LAYOUT

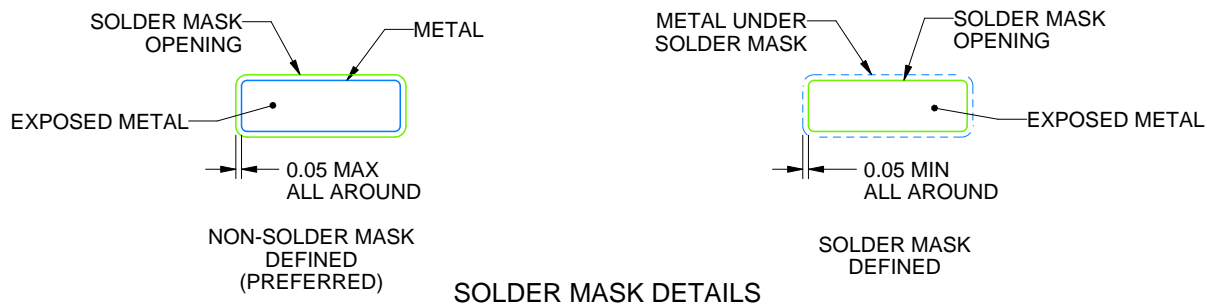
DGN0008G

PowerPAD™ HVSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 15X



SOLDER MASK DETAILS

4225480/C 11/2024

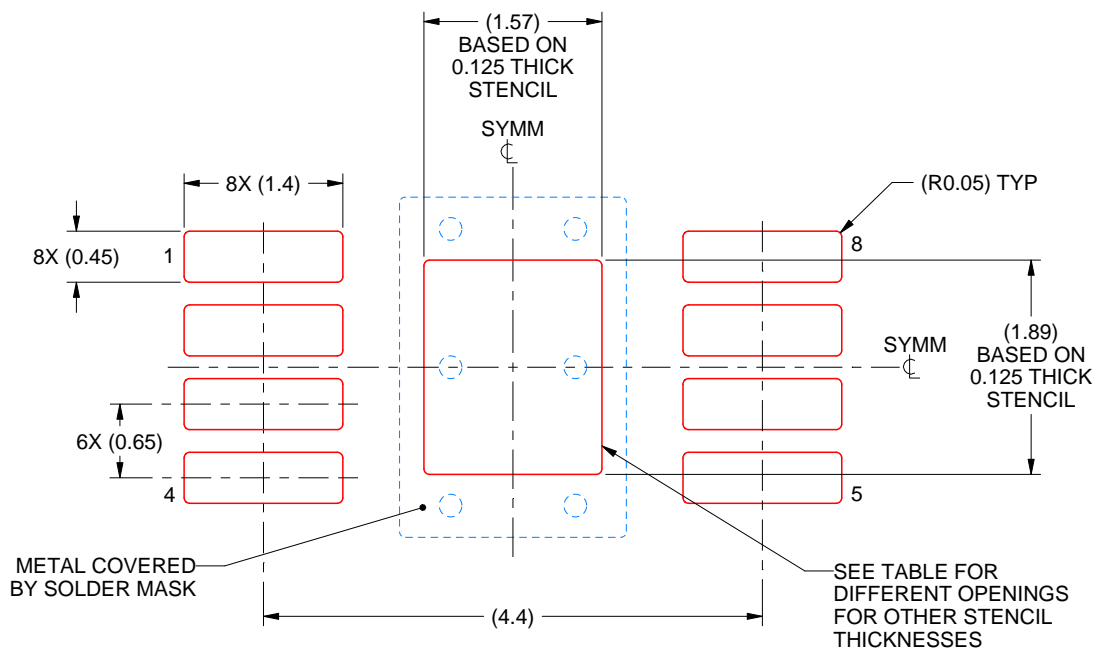
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
9. Size of metal pad may vary due to creepage requirement.

**DGN0008G**

## PowerPAD™ HVSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



## SOLDER PASTE EXAMPLE

EXPOSED PAD 9:  
100% PRINTED SOLDER COVERAGE BY AREA  
SCALE: 15X

STENCIL THICKNESS	SOLDER STENCIL OPENING
0.1	1.76 X 2.11
0.125	1.57 X 1.89 (SHOWN)
0.15	1.43 X 1.73
0.175	1.33 X 1.60

4225480/C 11/2024

NOTES: (continued)

10. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
11. Board assembly site may have different recommendations for stencil design.

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